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मानक

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Jawaharlal Nehru

“Step Out From the Old to the New”

IS/IEC 60947-5-1 (2003): Low-Voltage Switchgear and Controlgear, Part 5: Control Circuit Devices and Switching Elements, Section 1: Electromechanical Control Circuit Devices [ETD 7: Low Voltage Switchgear and Controlgear]



“ज्ञान से एक नये भारत का निर्माण”

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Bhartrihari—Nitiśatakam

“Knowledge is such a treasure which cannot be stolen”

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भारतीय मानक
निम्न-वोल्टता के स्विचगियर और नियंत्रणगियर
भाग 5 परिपथ नियन्त्रण उपकरण और स्विचिंग घटक
अनुभाग 1 विद्युत-यांत्रिक परिपथ नियंत्रण उपकरण

Indian Standard
LOW-VOLTAGE SWITCHGEAR AND CONTROLGEAR
PART 5 CONTROL CIRCUIT DEVICES AND SWITCHING ELEMENTS
Section 1 Electromechanical Control Circuit Devices

ICS 29.120.40; 29.130.20

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BUREAU OF INDIAN STANDARDS
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NATIONAL FOREWORD

This Indian Standard (Part 5/Sec 1) which is identical with IEC 60947-5-1 : 2003 'Low-voltage switchgear and controlgear — Part 5-1: Control circuit devices and switching elements — Electromechanical control circuit devices' issued by the International Electrotechnical Commission (IEC) was adopted by the Bureau of Indian Standards on the recommendation of the Low-Voltage Switchgear and Controlgear Sectional Committee and approval of the Electrotechnical Division Council.

This standard supersedes IS 13947 (Part 5/Sec 1) : 2004 'Low-voltage switchgear and controlgear — Specification: Part 5 Control circuit devices and switching elements, Section 1 Electromechanical control circuit devices (*first revision*)'.

This standard is to be read in conjunction with IS/IEC 60947-1 : 2004 'Low-voltage switchgear and controlgear: Part 1 General rules'.

The text of IEC Standard has been approved as suitable for publication as an Indian Standard without deviations. Certain conventions are, however, not identical to those used in Indian Standards. Attention is particularly drawn to the following:

- a) Wherever the words 'International Standard' appear referring to this standard, they should be read as 'Indian Standard'.
- b) Comma (,) has been used as a decimal marker, while in Indian Standards, the current practice is to use a point (.) as the decimal marker.

In this adopted standard, reference appears to certain International Standards for which Indian Standards also exist. The corresponding Indian Standards, which are to be substituted in their respective places, are listed below along with their degree of equivalence for the editions indicated:

<i>International Standard</i>	<i>Corresponding Indian Standard</i>	<i>Degree of Equivalence</i>
IEC 60050 (441) : 1984 International Electrotechnical Vocabulary (IEV) — Chapter 441: Switchgear, controlgear and fuses	IS 1885 (Part 17) : 1979 Electrotechnical vocabulary: Part 17 Switchgear and controlgear (<i>first revision</i>)	Technically Equivalent
IEC 60050 (446) : 1983 International Electrotechnical Vocabulary (IEV) — Chapter 446: Electrical relays	IS 1885 (Part 9) : 1992 Electrotechnical vocabulary: Part 9 Electrical relays (<i>first revision</i>)	Identical
IEC 60068-2-6 : 1995 Environmental testing — Part 2: Tests — Test Fc: Vibration (sinusoidal)	IS 9000 (Part 8) : 1981 Basic environmental testing procedures for electronic and electrical items: Part 8 Vibration (sinusoidal) test	Technically Equivalent
IEC 60068-2-14 : 1984 Environmental testing — Part 2: Tests — Test N: Change of temperature	IS 9000 (Part 14/Sec 1 to 3) : 1988 Basic environmental testing procedures for electronic and electrical items: Part 14 Test N: Change of temperature (<i>first revision</i>)	do

<i>International Standard</i>	<i>Corresponding Indian Standard</i>	<i>Degree of Equivalence</i>
IEC 60068-2-27 : 1987 Environmental testing — Part 2: Tests — Test Ea and guidance: Shock	IS 9000 (Part 17/Sec 1) : 2000 Guidance for environmental testing: Part 17 Impact test, Section 1 Shock test (Test Ea) (<i>first revision</i>)	Technically Equivalent
IEC 60068-2-30 : 1980 Environmental testing — Part 2: Tests — Test Db and guidance: Damp heat, cyclic (12+12-hour cycle)	IS 9000 (Part 5/Sec 1 and 2) : 1981 Basic environmental testing procedures for electronic and electrical items: Part 5 Damp heat (cyclic) test	do
IEC 60112 : 2003 Method for the determination of the proof and the comparative tracking indices of solid insulating materials	IS 2824 : 2007 Method for the determination of the proof and the comparative tracking indices of solid insulating materials (<i>second revision</i>)	Identical
IEC 60947-1 : 1999 ¹⁾ Low-voltage switchgear and controlgear — Part 1: General rules	IS/IEC 60947-1 : 2004 Low-voltage switchgear and controlgear: Part 1 General rules	Technically Equivalent
IEC 60947-4-1 : 2002 Low-voltage switchgear and controlgear — Part 4-1: Contactors and motor-starters — Electromechanical contactors and motor-starters	IS/IEC 60947-4-1 : 2002 Low-voltage switchgear and controlgear: Part 4 Contactors and motor-starters, Section 1 Electromechanical contactors and motor-starters	Identical
IEC 61000-4-2 : 1995 Electromagnetic compatibility (EMC) — Part 4-2: Testing and measurement techniques — Electrostatic discharge immunity test	IS 14700 (Part 4/Sec 2) : 1999 Electromagnetic compatibility (EMC): Part 4 Testing and measurement techniques, Section 2 Electrostatic discharge immunity test	Technically Equivalent
IEC 61000-4-3 : 2002 Electromagnetic compatibility (EMC) — Part 4-3: Testing and measurement techniques — Radiated, radio-frequency, electromagnetic field immunity test	IS 14700 (Part 4/Sec 3) : 2005 Electromagnetic compatibility (EMC): Part 4 Testing and measurement techniques, Section 3 Radiated, radio-frequency, electromagnetic field immunity test	Identical
IEC 61000-4-4 : 1995 Electromagnetic compatibility (EMC) — Part 4: Testing and measurement techniques — Section 4: Electrical fast transient/burst immunity test	IS 14700 (Part 4/Sec 4) : 1999 Electromagnetic compatibility (EMC): Part 4 Testing and measurement techniques, Section 4 Electrical fast transient/burst immunity test	Technically Equivalent
IEC 61000-4-8 : 1993 Electromagnetic compatibility (EMC) — Part 4-8: Testing and measurement techniques — Power frequency magnetic field immunity test	IS 14700 (Part 4/Sec 8) : 1999 Electromagnetic Compatibility (EMC): Part 4 Testing and measurement techniques, Section 8 Power frequency magnetic field immunity test	do
CISPR 11 : 1997 Industrial, scientific and medical (ISM) radio-frequency equipment — Electromagnetic disturbance characteristics — Limits and methods of measurement	IS 6873 (Part 4) : 1999 Limits and methods of measurement of radio disturbance characteristics: Part 4 Industrial, scientific and medical (ISM) radio-frequency equipment (<i>first revision</i>)	do

The technical committee responsible for the preparation of this standard has reviewed the provisions of the following International Standards referred in this adopted standard and has decided that they are acceptable for use in conjunction with this standard:

¹⁾ Since revised and adopted as IS/IEC 60947-1 : 2004.

IS/IEC 60947-5-1 : 2003

<i>International Standard</i>	<i>Title</i>
IEC 60073 : 2002	Basic and safety principles for man-machine interface, marking and identification — Coding principles for indicators and actuators
IEC 60255-8 : 1990	Electrical relays — Part 8: Thermal electrical relays
IEC 61000-4-5 : 1995	Electromagnetic compatibility (EMC) — Part 4-5: Testing and measurement techniques — Surge immunity tests
IEC 61000-4-6 : 1996	Electromagnetic compatibility (EMC) — Part 4-6: Testing and measurement techniques — Immunity to conducted disturbances, induced by radio-frequency fields
IEC 61000-4-11 : 1994	Electromagnetic compatibility (EMC) — Part 4-11: Testing and measurement techniques — Voltage dips, short interruptions and voltage variation immunity tests
IEC 61000-4-13 : 2002	Electromagnetic compatibility (EMC) — Part 4-13: Testing and measurement techniques — Harmonics and interharmonics including mains signalling at a.c. power port, low-frequency immunity tests
IEC 61140 : 2001	Protection against electric shock — Common aspects for installation and equipment

Only the English text of the International Standard has been retained while adopting it as an Indian Standard, and as such the page numbers given here are not the same as in the IEC Publication.

For the purpose of deciding whether a particular requirement of this standard is complied with, the final value, observed or calculated, expressing the result of a test or analysis, shall be rounded off in accordance with IS 2 : 1960 'Rules for rounding off numerical values (*revised*)'. The number of significant places retained in the rounded off value should be the same as that of the specified value in this standard.

*Indian Standard***LOW-VOLTAGE SWITCHGEAR AND CONTROLGEAR****PART 5 CONTROL CIRCUIT DEVICES AND SWITCHING ELEMENTS****Section 1 Electromechanical Control Circuit Devices****1 General**

The provisions of the general rules, IEC 60947-1, are applicable to this standard, where specifically called for. General rules, clauses and subclauses thus applicable, as well as tables, figures and annexes are identified by a reference to IEC 60947-1, for example 1 2 3, Table 4 or Annex A of IEC 60947-1.

1.1 Scope and object

This part of IEC 60947 applies to control circuit devices and switching elements intended for controlling, signalling, interlocking, etc., of switchgear and controlgear.

It applies to control circuit devices having a rated voltage not exceeding 1 000 V a.c. (at a frequency not exceeding 1 000 Hz) or 600 V d.c.

However, for operational voltages below 100 V a.c. or d.c., see note 2 of 4.3.1.1.

This standard applies to specific types of control circuit devices such as:

- manual control switches, for example pushbuttons, rotary switches, foot switches, etc.;
- electromagnetically operated control switches, either time-delayed or instantaneous, for example contactor relays;
- pilot switches, for example pressure switches, temperature sensitive switches (thermostats), programmers, etc.;
- position switches, for example control switches operated by part of a machine or mechanism;
- associated control circuit equipment, for example indicator lights, etc.

NOTE 1 A control circuit device includes (a) control switch(es) and associated devices such as (an) indicator light(s).

NOTE 2 A control switch includes (a) switching element(s) and an actuating system.

NOTE 3 A switching element may be a contact element or a semiconductor element.

It also applies to specific types of switching elements associated with other devices (whose main circuits are covered by other standards) such as:

- auxiliary contacts of a switching device (e.g. contactor, circuit breaker, etc.) which are not dedicated exclusively for use with the coil of that device;
- interlocking contacts of enclosure doors;
- control circuit contacts of rotary switches;
- control circuit contacts of overload relays.

IS/IEC 60947-5-1 : 2003

Contactor relays shall also meet the requirements and tests of IEC 60947-4-1 except for the utilization category which shall comply with this standard.

This standard does not include the relays covered in IEC 60255 or automatic electrical control devices for household and similar purposes.

The colour requirements of indicator lights, pushbuttons, etc., are found in IEC 60073 and also in publication 2 of the International Commission of Illumination (CIE).

The object of this standard is to state:

- a) The characteristics of control circuit devices.
- b) The electrical and mechanical requirements with respect to:
 - 1) The various duties to be performed.
 - 2) The significance of the rated characteristics and of the markings.
 - 3) The tests to verify the rated characteristics.
- c) The functional requirements to be satisfied by the control circuit devices with respect to:
 - 1) Environmental conditions, including those of enclosed equipment.
 - 2) Dielectric properties.
 - 3) Terminals.

1.2 Normative references

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60050(441):1984, *International Electrotechnical Vocabulary (IEV) – Chapter 441: Switchgear, controlgear and fuses*
Amendment 1 (2000)

IEC 60050(446):1983, *International Electrotechnical Vocabulary (IEV) – Chapter 446: Electrical relays*

IEC 60068-2-6:1995, *Environmental testing – Part 2: Tests – Test Fc: Vibration (sinusoidal)*

IEC 60068-2-14:1984, *Environmental testing – Part 2: Tests – Test N: Change of temperature*
Amendment 1 (1986)

IEC 60068-2-27:1987, *Environmental testing – Part 2: Tests – Test Ea and guidance: Shock*

IEC 60068-2-30:1980, *Environmental testing – Part 2: Tests – Test Db and guidance: Damp heat, cyclic (12 + 12 hour cycle)*
Amendment 1 (1985)

IEC 60073 2002, *Basic and safety principles for man-machine interface, marking and identification – Coding principles for indications and actuators*

IEC 60112:2003, *Method for the determination of the proof and the comparative tracking indices of solid insulating materials*

IEC 60255 (all parts), *Electrical relays*

IEC 60617 (all parts), *Graphical symbols for diagrams*

IEC 60947-1:1999, *Low-voltage switchgear and controlgear – Part 1: General rules*
Amendment 1 (2000)
Amendment 2 (2001)

IEC 60947-4-1:2000, *Low-voltage switchgear and controlgear – Part 4-1: Contactors and motor-starters – Electromechanical contactors and motor-starters*

IEC 61000-4-2:1995, *Electromagnetic compatibility (EMC) – Part 4-2: Testing and measurement techniques – Electrostatic discharge immunity test*
Amendment 1 (1998)
Amendment 2 (2000)

IEC 61000-4-3:2002, *Electromagnetic compatibility (EMC) – Part 4-3: Testing and measurement techniques – Radiated, radio-frequency, electromagnetic field immunity test*

IEC 61000-4-4:1995, *Electromagnetic compatibility (EMC) – Part 4: Testing and measurement techniques – Section 4: Electrical fast transient/burst immunity test*
Amendment 1 (2000)
Amendment 2 (2001)

IEC 61000-4-5:1995, *Electromagnetic compatibility (EMC) – Part 4-5: Testing and measurement techniques – Surge immunity tests*
Amendment 1 (2000)

IEC 61000-4-6:1996, *Electromagnetic compatibility (EMC) – Part 4-6: Testing and measurement techniques – Immunity to conducted disturbances, induced by radio-frequency fields*
Amendment 1 (2000)

IEC 61000-4-8:1993, *Electromagnetic compatibility (EMC) – Part 4-8: Testing and measurement techniques – Power frequency magnetic field immunity test*
Amendment 1 (2000)

IEC 61000-4-11:1994, *Electromagnetic compatibility (EMC) – Part 4-11: Testing and measurement techniques – Voltage dips, short interruptions and voltage variations immunity tests*
Amendment 1 (2000)

IEC 61000-4-13:2002, *Electromagnetic compatibility (EMC) – Part 4-13: Testing and measurement techniques – Harmonics and interharmonics including mains signalling at a.c. power port, low-frequency immunity tests*

IEC 61140:2001, *Protection against electric shock – Common aspects for installation and equipment*

CISPR 11:1997, *Industrial, scientific and medical (ISM) radio-frequency equipment – Electromagnetic disturbance characteristics – Limits and methods of measurement*
Amendment 1 (1999)

2 Definitions

For the purposes of this part of IEC 60947 the definitions of IEC 60947-1 and the following additions apply:

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2.1 Basic definitions

2.1.1

control circuit device

an electrical device intended for the controlling, signalling, interlocking, etc., of switchgear and controlgear

NOTE Control circuit devices may include associated devices dealt with in other standards, such as instruments, potentiometers, relays, in so far as associated devices are used for the purposes specified above.

2.1.2

control switch (for control and auxiliary circuits)

a mechanical switching device which serves the purpose of controlling the operation of switchgear or controlgear, including signalling, electrical interlocking, etc.

NOTE 1 A control switch consists of one or more contact elements with a common actuating system.

NOTE 2 This definition differs from IECV 441-14-46 since a control switch may include semiconductor elements or contact elements (see 2.3.2 and 2.3.3).

2.1.3

control switch suitable for isolation

a control switch which, in the open position, complies with the requirements specified for the isolating function (see 2.1.19 and 7.2.3.1 b) of IEC 60947-1)

NOTE Such control switches are intended to provide a higher degree of safety to personnel when working on the equipment controlled. For this reason, they have to be manually actuated relying on the intelligence of instructed persons to react in case they would fail to operate, e.g. in case of insufficiently opened contacts.

2.1.4

control station

an assembly of one or more control switches fixed on the same panel or located in the same enclosure

[IEV 441-12-08]

NOTE A control station panel or enclosure may also contain related equipment, e.g. potentiometers, signal lamps, instruments, etc.

2.2 Control switches

2.2.1

automatic control switches

NOTE Automatic control switches are operated by automatic control (see 2.4.5 of IEC 60947-1). They are also designated as *pilot switches* (see 2.2.18 of IEC 60947-1).

2.2.1.1

instantaneous contactor relay

a contactor relay operating without any intentional time delay

[IEV 441-14-36]

NOTE Unless otherwise stated, a contactor relay is an instantaneous contactor relay.

2.2.1.2

time-delay contactor relay

a contactor relay with specified time-delay characteristics

[IEV 441-14-37]

NOTE 1 The time-delay may be associated with energization (e-delay) or with de-energization (d-delay) or both

NOTE 2 A time-delay contactor relay may also incorporate instantaneous contact elements

2.2.1.3

position switch

A pilot switch the actuating system of which is operated by a moving part of the machine, when this part reaches a predetermined position

[IEV 441-14-49]

2.2.1.4

programmer

a control switch having a multiplicity of switching elements which, after initiation, operates in a defined sequence

2.2.2

manually operated control switches

NOTE Manually operated control switches are operated by manual control (see 2.4.4 of IEC 60947-1).

2.2.2.1

push-button

a control switch having an actuator intended to be operated by force exerted by a part of the human body, usually the finger or palm of the hand, and having stored energy (spring) return

[IEV 441-14-53]

2.2.2.2

pull-button

a control switch having an actuator intended to be operated by manual pull, and having stored energy (spring) return

2.2.2.3

push-pull button

a control switch having an actuator intended to be operated by manual push and returned to its initial position by manual pull, or vice versa

NOTE There are also «push-push» or «push-turn» or other combinations of buttons.

2.2.2.4

rotary button (e.g.: selector switch)

a combination of push-button type switching elements having an actuator operated by a manual rotation (see also 2.2.2.15 to 2.2.2.18 inclusive)

NOTE A rotary push-button may have more than two positions; it may or may not have a spring return.

2.2.2.5

latched push-button

a push-button with spring return, but which remains in the actuated position until a latch is released by a separate action

NOTE The latching may be released by subsequent actuation (such as pushing, turning, etc.) of the same or of an adjacent push-button or by the action of an electromagnet, etc.

2.2.2.6

locked push-button

a push-button which may be secured in one or more of its positions by a separate action

NOTE The locking may be obtained by turning the button, by turning a key, by operating a lever, etc.

2.2.2.7

key-operated push-button

a push-button which can only be operated as long as a key remains inserted

NOTE Key withdrawal may be provided at any position.

2.2.2.8

time-delay push-button

a push-button the contacts of which return to the initial position only after a pre-determined interval of time following the release of the actuating force

2.2.2.9

delayed action push-button

a push-button in which the switching operation does not occur until after the force on the button has been maintained for a pre-determined interval of time

2.2.2.10

illuminated push-button

a push-button incorporating a signalling lamp in the button

2.2.2.11

covered push-button

a push-button in which the button is protected against inadvertent operation by a lid or a cover

2.2.2.12

shrouded push-button

a push button in which the button is protected against inadvertent operation in certain directions

2.2.2.13

free push-button

a push-button in which the rotation of the actuator around its axis is not limited

2.2.2.14

guided push-button

a push-button in which the rotation of the actuator around its axis is prevented

NOTE Examples of guided push-buttons: the actuators of which are keyed, square or rectangular, etc.

2.2.2.15

rotary control switch (abbreviation: rotary switch)

a control switch having an actuator intended to be operated by rotation

2.2.2.16

key-operated rotary switch

a rotary switch where a key is used as the actuator

NOTE Key withdrawal may be provided at any position.

2.2.2.17

limited movement rotary switch

a rotary switch with a restricted angular movement of its actuator

2.2.2.18

unidirectional movement rotary switch

a rotary switch in which the actuating system allows rotation in one direction only

2.2.2.19

joy stick

a control switch having an actuator consisting of a pin or stick projecting essentially at a right angle from the panel or enclosure when in one of its positions and intended to be operated by angular displacement

NOTE 1 A joy stick may have more than two positions associated with different directions of the displacement of the stick and operating the contact elements differently: such a joy stick is referred to as a joy stick selector

NOTE 2 The pin or stick may or may not have a spring return.

2.2.2.20

wobble stick

a joy stick which operates all contact elements alike, whatever be the direction of the displacement

2.2.2.21

foot switch (pedal)

a control switch having an actuator intended to be operated by force exerted by a foot

[IEV 441-14-52 modified]

2.3 Parts of control switches

2.3.1

switching element

a switching element may be a semiconductor element (see 2.3.2) or a contact element (see 2.3.3)

2.3.2

semiconductor element

an element designed to switch the current of an electric circuit by means of the controlled conductivity of a semiconductor

2.3.3

contact element (of a control switch)

the parts, fixed and movable, conducting and insulating, of a control switch necessary to close and open one single conducting path of a circuit

NOTE 1 The contact element and the actuating system may form an indivisible unit, but frequently one or more contact elements may be combined with one or more actuating system or systems. The actuating systems may be different.

NOTE 2 Definitions relating to various kinds of contact elements are given in 2.3.3.1 to 2.3.3.10 inclusive

NOTE 3 This definition does not include control coils and magnet systems.

The following definitions refer to a single contact element of a control switch:

2.3.3.1

single gap contact element (see Figures 4 a) and 4 c))

a contact element which opens or closes the conducting path of its circuit on one location only

2.3.3.2

double gap contact element (see Figures 4 b), 4 d) and 4 e))

a contact element which opens or closes the conducting path of its circuit in two locations in series

2.3.3.3

make-contact element (normally open)

a contact element which closes a conducting path when the control switch is actuated

2.3.3.4

break-contact element (normally closed)

a contact element which opens a conducting path when the control switch is actuated

2.3.3.5

change-over contact elements (see Figures 4 c), 4 d) and 4 e))

a contact element combination which includes one make-contact element and one break-contact element

2.3.3.6

pulse (fleeting) contact element

a contact element which opens or closes a circuit for a part of the travel during the transition of the actuator from one position to another

2.3.3.7

electrically separated contact elements

contact elements belonging to the same control switch, but adequately insulated from each other so that they can be connected into electrically separated circuits

[IEV 441-15-24]

2.3.3.8

independent (snap) action contact element

a contact element of a manual or automatic control device in which the velocity of contact motion is substantially independent of the velocity of motion of the actuator

2.3.3.9

dependent action contact element

a contact element of a manual or automatic control device in which the velocity of contact motion depends on the velocity of motion of the actuator

2.3.3.10

contact unit

a contact element or contact element combination which can be combined with similar units operated by a common actuating system

2.3.4

button

the external end of the actuator of a push-button, to which the actuating force is applied

2.3.4.1

flush-button

a button which is substantially level with the adjacent fixed surrounding surface when in its initial position and is below this surface when it is operated

2.3.4.2

recessed button

a button which is below the adjacent fixed surrounding surface in both its initial and operated positions

2.3.4.3

extended button

a button which protrudes above the adjacent fixed surrounding surface both in its initial position and in its operated position

2.3.4.4

mushroom button

a button, the protruding end of which has an enlarged diameter

2.3.5

locating mechanism (of a rotary switch)

that part of the actuating system which retains the actuator and/or the contact elements in their positions

2.3.6

end stop

a device that limits the travel of a moving part

NOTE An end stop may relate either to the actuator or to the contact element.

2.4 Operation of control switches

2.4.1 Operation of contactor relays

2.4.1.1

e-delay (of a contact element)

a delay in the operation of a contact element of a contactor relay, following the energization of the coil of the electromagnet of this contactor relay

Example: delay to close make-contacts (ON delay).

2.4.1.2

d-delay (of a contact element)

a delay in the operation of a contact element of a contactor relay, following the de-energization of the coil of the electromagnet of this contactor relay

Example: delay to open make-contacts (OFF delay)

Note for 2.4.1.1 and 2.4.1.2 – The terms 'e-delay' and 'd-delay' may be applied to any kind of contact elements (see 2.3.3).

2.4.1.3

fixed delay (of a contact element)

a delay in the operation of a contact element of a contactor relay, which is not intended to be adjusted in value

2.4.1.4

adjustable delay (of a contact element)

a delay in the operation of a contact element of a contactor relay, which is intended to be adjusted to different values after the installation of the contactor relay

2.4.2 Operation of pilot switches

2.4.2.1

actuating quantity

the physical quantity, the value of which is decisive for the actuation or non-actuation of a pilot switch

2.4.2.2

operating value

the value of the actuating quantity which is sufficient to cause a pilot switch to be actuated

2.4.2.3

return value

the value of the actuating quantity which has to be re-established in order to cause an actuated pilot switch to return to its position of rest

2.4.2.4

differential value

the difference between the operating value and the return value

2.4.3 Operation of rotary switches

2.4.3.1

definite position (abbreviation: position) (of a rotary switch)

a position into which the locating mechanism pulls the rotary switch and retains it as long as the actuating moment does not exceed a certain value

2.4.3.2

position of rest

a stable (definite) position into which the locating mechanism tends to move back and retain the rotary switch by stored energy

2.4.3.3

transit position

a (definite) position in which the locating mechanism produces an intended marked change in the operating moment, but in which the actuator cannot remain by itself

2.4.3.4

biased position

a (definite) position of a rotary switch in which the actuator is pulled against a stop from which it will return to a position of rest by means of stored energy (for example, by means of a spring)

NOTE During the transfer from a biased position to the adjacent position of rest, the rotary switch may pass through one or more transit positions.

2.4.3.5

latched position

a biased position in which the return mechanism is held by a latching arrangement

NOTE The latching arrangement may be released manually or otherwise.

2.4.3.6

locked position

a (definite) position in which a rotary switch is secured by separate action

NOTE The locking may be obtained by turning a key, operating a lever, etc.

2.4.3.7

operating diagram

the representation of the intended order in which the contact elements of a rotary switch operate as a result of actuation

2.4.4 Operation of mechanically operated control switches

2.4.4.1

pre-travel of the actuator (dimension *a* on Figure 2)

the maximum travel of the actuator which causes no travel of the contact elements

2.4.4.2

over-travel of the actuator

the travel of the actuator after all the contacts have reached their closed (open) position

2.4.4.3

direct drive

a connection between actuator and contact element that excludes any pre-travel of the actuator

2.4.4.4

positive drive

a connection between actuator and contact element such that the force applied to the actuator is directly transmitted to the contact element

2.4.4.5

limited drive

a connection between actuator and contact element that limits the force transmitted to the contact element

2.4.4.6

minimum starting force (or moment)

the smallest value of force (or moment) initiating the pre-travel of the actuator

2.4.4.7

minimum actuating force (or moment)

the minimum value of the force (or moment) to be applied to the actuator that will cause all contacts to reach their closed (open) position

2.4.4.8

pre-travel of the contact element (dimension *b* on Figure 2)

the relative movement which occurs within the contact element before the contacts make (break)

2.4.4.9

over-travel of the contact element (dimension d on Figure 2)

the relative movement which occurs within the contact element after the contacts have reached the make (break) position

2.4.4.10

bounce time

for a contact which is closing (opening) its circuit, the time interval between the instant when the contact circuit first closes (opens) and the instant when the circuit is finally closed (opened)

[IEV 446-17-13]

3 Classification

3.1 Contact elements

Contact elements may be classified as follows:

- a) Utilization categories (see 4.4).
- b) Electrical ratings based on utilization categories (see Annex A).
- c) One of the following form letters (see Figure 4):
 - 1) Form A – Single gap make-contact element;
 - 2) Form B – Single gap break-contact element;
 - 3) Form C – Single gap make-break three terminal change-over contact element;
 - 4) Form X – Double gap make-contact element;
 - 5) Form Y – Double gap break-contact element;
 - 6) Form Z – Double gap make-break four terminal change-over contact element.
- d) Other types not included in c).

NOTE 1 Regarding Figure 4e), the two moving contact elements are electrically separated (see 2.3.3.7).

NOTE 2 Distinction is made between make before break (overlap) change-over contact elements where the two circuits are both closed for a part of the travel of the moving contacts from one position to the other, and break before make (non-overlap) change-over contact elements where the two circuits are both open for a part of the travel of the moving contacts from one position to the other. Unless otherwise stated, change-over contact elements are break before make.

3.2 Control switches

Control switches may be classified according to the contact element and the nature of the actuating system, e.g. push-buttons, form X.

3.3 Control circuit devices

Control circuit devices may be classified according to the control switch and the associated control circuit equipment, e.g. push-buttons plus indicator lights.

3.4 Time delay switching elements

Distinction is made according to how the time delay of a switching element is achieved, e.g. electrical delay, magnetic delay, mechanical delay, or pneumatic delay.

3.5 Control switch mounting

The control switch mounting may be classified by the mounting hole size, e.g. D12, D16, D22, D30 (see 6.3.1).

4 Characteristics

4.1 Summary of characteristics

The characteristics of control circuit devices and switching elements should be stated in the following terms, where such terms are applicable:

- type of equipment (see 4.2);
- rated and limiting values for switching elements (see 4.3);
- utilization categories of switching elements (see 4.4);
- normal and abnormal load characteristics (see 4.3.5);
- switching overvoltages (see 4.9).

4.1.1 Operation of a control switch

The principal application of a control switch is the switching of loads as indicated for the various utilization categories in Table 1.

Other applications, e.g. the switching of tungsten filament lamps, small motors, etc., are not dealt with in detail in this standard, but are mentioned in 4.3.5.2.

4.1.1.1 Normal conditions of use

The normal use of a control switch is to close, maintain and open circuits in accordance with the utilization category shown in Table 1. Also refer to Table 4.

4.1.1.2 Abnormal conditions of use

Abnormal conditions may arise, for example, when an electromagnet, although energized, has failed to close. Refer to Table 5.

A control switch shall be able to break the current corresponding to such conditions of use.

4.2 Type of control circuit device or switching element

The following shall be stated:

4.2.1 Kind of control circuit device

- manual control switches, e.g. push-buttons, rotary switches, foot switches, etc.;
- electromagnetically operated control switches, either time delayed or instantaneous, e.g. contactor relays;
- pilot switches, e.g. pressure switches, temperature sensitive switches (thermostats), programmers, etc.;
- position switches;
- associated control equipment, e.g. indicator lights, etc.

4.2.2 Kind of switching elements

- auxiliary contacts of a switching device (e.g. contactor, circuit breaker, etc.) which are not dedicated exclusively for use with the coil of that device;
- interlocking contacts of enclosure doors;
- control circuit contacts of rotary switches;
- control circuit contacts of overload relays.

4.2.3 Number of poles

4.2.4 Kind of current

Alternating current or direct current.

4.2.5 Interrupting medium

Air, oil, gas, vacuum, etc.

4.2.6 Operating conditions

4.2.6.1 Method of operation

Manual, electromagnetic, pneumatic, electro-pneumatic.

4.2.6.2 Method of control

- automatic;
- non-automatic;
- semi-automatic.

4.3 Rated and limiting values for switching elements

The rated values established for the switching elements of a control circuit device shall be stated in accordance with 4.3.1 to 4.3.5 inclusive but it is not necessary to specify all the values listed.

4.3.1 Rated voltages (of a switching element)

A switching element is defined by the following rated voltages:

4.3.1.1 Rated operational voltage (U_e)

Subclause 4.3.1.1 of IEC 60947-1 applies with the following additions:

For three-phase circuits, U_e is stated as r.m.s. voltage between phases.

NOTE 1 A switching elements may be assigned a number of combinations of rated operational voltage and rated operational current.

NOTE 2 Control switches dealt with in this standard are not normally intended to be used at very low voltages and they may not be suitable for such a service. It is therefore recommended to seek the advice of the manufacturer concerning any application with a low value of operational voltage, e.g. below 100 V a.c. or d.c.

4.3.1.2 Rated insulation voltage (U_i)

Subclause 4.3.1.2 of IEC 60947-1 applies.

4.3.1.3 Rated impulse withstand voltage (U_{imp})

Subclause 4.3.1.3 of IEC 60947-1 applies.

4.3.2 Currents

A switching element is characterized by the following currents:

4.3.2.1 Conventional free air thermal current (I_{th})

Subclause 4.3.2.1 of IEC 60947-1 applies.

4.3.2.2 Conventional enclosed thermal current (I_{the})

Subclause 4.3.2.2 of IEC 60947-1 applies.

4.3.2.3 Rated operational current (I_e)

The first paragraph of 4.3.2.3 of IEC 60947-1 applies.

4.3.3 Rated frequency

Subclause 4.3.3 of IEC 60947-1 applies.

4.3.4 Vacant

4.3.5 Normal and abnormal load characteristics

4.3.5.1 Rated making and breaking capacities and behaviour of switching elements under normal conditions

A switching element shall comply with both requirements given in Table 4 corresponding to the assigned utilization category and the requirements according to the rated operational voltage.

NOTE 1 For a switching element to which a utilization category is assigned, it is not necessary to specify separately a making and breaking capacity.

NOTE 2 A switching element used for the switching of small motors and tungsten filament lamp loads shall be assigned a utilization category given in IEC 60947-4-1 and comply with the appropriate corresponding requirements in that publication.

4.3.5.2 Making and breaking capacities under abnormal conditions

A switching element shall comply with the requirements given in Table 5 corresponding to the assigned utilization category.

NOTE An example of an abnormal condition of use is one where the electromagnet does not operate and the switching elements have to interrupt the making current.

4.3.6 Short-circuit characteristics

4.3.6.1 Rated conditional short-circuit current

Subclause 4.3.6.4 of IEC 60947-1 applies.

4.4 Utilization categories for switching elements

The utilization categories as given in Table 1 are considered standard. Any other types of application shall be based on agreement between manufacturer and user, but information given in the manufacturer's catalogue or tender may constitute such an agreement.

Table 1 – Utilization categories for switching elements

Kind of current	Category	Typical applications
Alternating current	AC-12	Control of resistive loads and solid state loads with isolation by optocouplers
	AC-13	Control of solid state loads with transformer isolation
	AC-14	Control of small electromagnetic loads (≤ 72 VA)
	AC-15	Control of electromagnetic loads (> 72 VA)
Direct current	DC-12	Control of resistive loads and solid state loads with isolation by optocouplers
	DC-13	Control of electromagnets
	DC-14	Control of electromagnetic loads having economy resistors in circuit

4.5 Vacant

4.6 Vacant

4.7 Vacant

4.8 Vacant

4.9 Switching overvoltages

Subclause 4.9 of IEC 60947-1 applies.

4.10 Electrically separated contact elements

The manufacturer shall state whether the contact elements of a control circuit device are electrically separated or not (see 2.3.3.7).

4.11 Actuating quantities for pilot switches

The operating value and return value of the actuating quantity are to be determined on uniform rising values and normal falling values of the actuating quantity. Unless otherwise stated, the rate of change shall be regular and such that the operating (or return) value is reached in not less than 10 s.

The operating value and the return value may both be fixed values, or one of them or both may be adjustable (or the differential value may be adjustable).

Where appropriate, the manufacturer shall indicate a withstand value, either a maximum value higher than the highest setting of the operating value or a minimum value lower than the lowest setting of the return value. A withstand value implies no damage to the pilot switch or no change in its characteristics.

4.12 Pilot switches having two or more contact elements

Pilot switches having two or more contact elements which are not individually adjustable may have different operating and return values for each contact element.

A pilot switch having two or more contact elements which are individually adjusted is considered as a combination of pilot switches.

5 Product information

5.1 Nature of information

The following information shall be given by the manufacturer:

Identification

- a) The manufacturer's name or trade mark.
- b) A type designation or serial number that makes it possible to get the relevant information concerning the switching element (or the entire control switch) from the manufacturer or from his catalogue or by selection from Annex A.
- c) IEC 60947-5-1 if the manufacturer claims compliance with this standard.

Basic rated values and utilization

- d) Rated operational voltages (see 4.3.1.1).
- e) Utilization category and rated operational currents at the rated operational voltages of the control circuit device.
- f) Rated insulation voltage (see 4.3.1.2).
- g) Rated impulse withstand voltage (see 4.3.1.3), when determined.
- h) Switching overvoltage, if applicable (see 4.9).
- i) IP code, in case of an enclosed control circuit device (see 5.1 and Annex C of IEC 60947-1)
- j) Pollution degree (see 6.1.3.2).
- k) Type and maximum ratings of short-circuit protective device (see 8.3.4.3).
- l) Conditional short-circuit current if less than 1 000 A.
- m) Suitability for isolation, where applicable, with the symbol 07-13-06 of IEC 60617-7
- n) Indication of contact elements of same polarity.

5.2 Marking

5.2.1 General

Marking of data under a) and b) of 5.1 is mandatory on the nameplate of the control circuit device in order to permit the complete information to be obtained from the manufacturer

Marking shall be indelible and easily legible, and shall not be placed on screws and removable washers:

Whenever space permits, data under c) to n) shall be included on the nameplate, or on the control circuit device or otherwise in the manufacturer's published literature.

5.2.2 Terminal identification and marking

Subclause 7.1.7.4 of IEC 60947-1 applies.

5.2.3 Functional markings

Actuators may be identified by symbols in the form of engravings. If a stop-button carries any symbol engraved or marked on the actuator, then this symbol shall be a circle or an oval (signifying the value zero). The symbols circle or oval shall be used for stop-buttons only.

Letters or words may be used where the space available is sufficient to ensure a clear identification. In all other cases, identification markings shall be placed on permanent labels surrounding each actuator or closely adjacent to it.

5.2.4 Emergency stop

Control switch actuators intended to be used as "stop" control for emergency use shall be coloured red and, in the case of a push-button, be of mushroom shape.

5.2.5 Operating diagram

As rotary switches may have a multiplicity of contact elements and a multiplicity of actuator positions, it is necessary that the manufacturer indicates the relationship between the actuator positions and the associated contact element positions.

It is recommended that the relationship be given in the form of an operating diagram, examples of which are shown in Figure 1 together with explanatory notes.

5.2.5.1 Position indication

The position indication shall be clear, and the associated text or symbols shall be indelible and easily legible.

5.2.5.2 Terminal markings for operating diagrams

Terminal markings shall be clearly identifiable with respect to the operating diagram.

5.2.6 Time delay markings

For time-delay contactor relays, the markings shall include the value of the time delay in the case of a fixed delay and the range of time delay in the case of an adjustable delay.

In the case of more than one time-delay contact element, the relative delay between the operation of each contact element and the following one may be indicated for contact elements that follow the first delay.

If two or more contact elements have adjustable delays, it shall be indicated whether they are individually adjustable or not.

The manufacturer shall indicate, for each time-delay contact element, the characteristics of the delay, according to 2.4.1.1 or 2.4.1.2.

5.3 Instructions for installation, operation and maintenance

Subclause 5.3 of IEC 60947-1 applies.

5.4 Additional information

Additional information necessary for certain types of control circuit devices shall appear according to the relevant rules of the appropriate Annexes J and K.

Such additional information shall be supplied by the manufacturer and may be in the form of a wiring diagram or in the instruction sheet supplied with the control circuit device.

6 Normal service, mounting and transport conditions

Clause 6 of IEC 60947-1 applies with the following additions:

6.1.3.2 Pollution degree

Unless otherwise stated by the manufacturer, a control circuit device is intended for installation under environmental conditions of pollution degree 3. However, other pollution degrees may apply, depending upon the micro-environment.

6.3.1 Mounting of single hole mounted devices

The single hole mounted push-buttons and indicator lights are located in a circular hole of the panel, which may have a rectangular recess for a key.

The dimensions are indicated in Table 2:

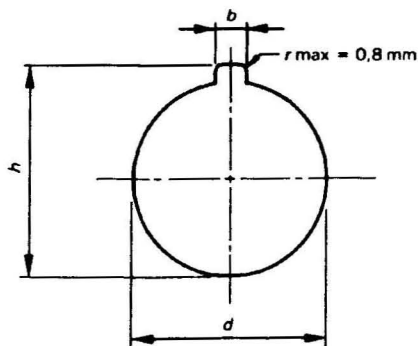


Table 2 – Mounting hole diameter and dimensions of the key recess (if any)

Taille	Mounting hole diameter, d mm	Key recess (if any)	
		Height, h mm	Width, b mm
D30	30,5 $\begin{smallmatrix} +0,5 \\ 0 \end{smallmatrix}$	33,0 $\begin{smallmatrix} +0,5 \\ 0 \end{smallmatrix}$	4,8 $\begin{smallmatrix} +0,2 \\ 0 \end{smallmatrix}$
D22	22,3 $\begin{smallmatrix} +0,4 \\ 0 \end{smallmatrix}$	24,1 $\begin{smallmatrix} +0,4 \\ 0 \end{smallmatrix}$	3,2 $\begin{smallmatrix} +0,2 \\ 0 \end{smallmatrix}$
D16	16,2 $\begin{smallmatrix} +0,2 \\ 0 \end{smallmatrix}$	17,9 $\begin{smallmatrix} +0,2 \\ 0 \end{smallmatrix}$	1,7 $\begin{smallmatrix} +0,2 \\ 0 \end{smallmatrix}$
D12	12,1 $\begin{smallmatrix} +0,2 \\ 0 \end{smallmatrix}$	13,8 $\begin{smallmatrix} +0,2 \\ 0 \end{smallmatrix}$	1,7 $\begin{smallmatrix} +0,2 \\ 0 \end{smallmatrix}$

6.3.1.1 Location of the key recess (if any)

The standardized position of the key is in the up position (12 o'clock) and associated with the b dimension in Table 3.

6.3.1.2 Range of panel thickness

The device, with or without the sealing gasket indicated by the manufacturer, shall be capable of being mounted on any thickness of panel between 1 mm and 6 mm, if necessary by the use of packing piece(s) supplied for the purpose.

NOTE The sealing gasket is not standardized.

6.3.1.3 Grouping of devices

When a number of devices of the sizes given in 6.3.1 are mounted in rows on a panel, the distances *a* between the mounting centres in the same row and *b* between the centre lines of the rows shall be not less than those given in Table 3, unless otherwise stated by the manufacturer.

**Table 3 – Preferred minimum distances
between centres of mounting holes**

Size	<i>a</i> mm	<i>b</i> mm
D30	50	65
D22	30	50
D16	25	25
D12	20	20

Distances *a* and *b* may be interchanged.

These values are intended to guide development; however, when it is intended to mount devices of different manufacture, the user shall establish the compatibility of the devices and ensure the clearances and creepage distances are maintained when the devices are installed and connected.

NOTE Depending on design details, connections, labels, etc., some devices may be capable of being mounted at distances less than those given in Table 3 in accordance with the indication of the manufacturer of the devices. On the other hand, certain types of devices may require distances greater than those given in Table 3.

7 Constructional and performance requirements

7.1 Constructional requirements

Subclause 7.1 of IEC 60947-1 applies except for 7.1.1, 7.1.2, 7.1.6, 7.1.8 and 7.1.12, and with the following additions:

7.1.1 Materials

Materials shall be suitable for the particular application and shall enable the equipment to comply with the relevant test requirements.

Special attention shall be called to flame and humidity resisting qualities, and to the necessity to protect certain insulating materials against humidity.

NOTE Requirements are under consideration.

7.1.2 Current-carrying parts and their connections

Current-carrying parts shall have the necessary mechanical strength and current-carrying capacity for their intended use.

For electrical connections, no contact pressure shall be transmitted through insulating material other than ceramic or other material with characteristics not less suitable, unless there is sufficient resiliency in the metallic parts to compensate for any possible shrinkage or yielding of the insulation material.

7.1.3 Clearances and creepage distances

For control switches for which the manufacturer has declared a value of rated impulse withstand voltage (U_{imp}), minimum values are given in Tables 13 and 15 of IEC 60947-1

Control switches for which the manufacturer has not declared a value of U_{imp} , shall have clearances and creepage distances in accordance with Annex D.

7.1.4.3 Actuating force (or moment)

The force (or moment) required to operate the actuator shall be compatible with the intended application, taking into account the size of the actuator, the type of enclosure or panel, the environment of the installation and the use for which it is intended.

The minimum starting force (or moment) shall be sufficiently large to prevent inadvertent operation; e.g. push-buttons and rotary switches to be used with enclosures complying with degrees of protection IPX5 or IPX6 shall not become actuated when hit by the jet of water applied during the test of the enclosed equipment.

7.1.4.4 Limitation of rotation (of a rotary switch)

When actuators with limited or unidirectional movement are used, they shall be fitted with robust means of limitation, capable of withstanding five times the actual maximum actuating moment.

7.1.4.5 Emergency stop

The actuator shall preferably latch in the actuated position with the control contact open. This latching shall be released by a separate action, e.g. by pulling, rotation, or by means of a key.

NOTE Additional requirements for emergency stop devices are given in IEC 60947-5-5.

7.1.6 Conditions for control switches suitable for isolation

A control switch suitable for isolation shall be manually operated with a positive opening operation (see Annex K) and shall comply with the isolating function in the open position (see 2.1.19 and 7.1.6 of IEC 60947-1).

The open position of a control switch suitable for isolation shall be a position in which the switch can remain when no actuating force is applied.

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In order to avoid unintentional reclosing, it shall be possible to prevent the operation of the control switches suitable for isolation when the contact elements are in the open position. This may be obtained by padlocking or by a latch which shall only be releasable by a special tool or key.

7.1.7 Class II control circuit devices

These devices shall not be provided with means for protective earthing (see IEC 61140).

For class II control circuit devices insulated by encapsulation, see Annex F.

7.1.8 Requirements for control devices with integrally connected cables

See Annex G.

7.2 Performance requirements

Subclauses 7.2.1.1 and 7.2.2 of IEC 60947-1 apply with the following additions:

7.2.1.2 Limits of operation of contactor relays

The limits of operation for contactor relays shall be in accordance with IEC 60947-4-1.

7.2.3 Dielectric properties

Subclause 7.2.3 of IEC 60947-1 applies with the following addition.

For Class II control circuit devices insulated by encapsulation, see Annex F.

7.2.4 Ability to make and break under normal and abnormal load conditions

7.2.4.1 Making and breaking capacities

a) *Making and breaking capacities under normal conditions*

The switching elements shall be capable of making and breaking currents without failure under the conditions stated in Table 4, for the required utilization categories and the number of operating cycles indicated, under the conditions specified in 8.3.3.5.2.

During this test the overvoltages generated shall not exceed the impulse withstand voltage values stated by the manufacturer (see 7.2.6).

b) *Making and breaking capacities under abnormal conditions*

The switching elements shall be capable of making and breaking currents without failure under the conditions stated in Table 5, for the required utilization categories and the number of operating cycles specified in Table 5.

7.2.4.2 Vacant

7.2.4.3 Durability

Subclause 7.2.4.3 of IEC 60947-1 applies with the following additions:

a) *Mechanical durability*

The mechanical durability of a control circuit device is verified, when needed, by a special test conducted at the discretion of the manufacturer. Instructions for conducting this test are given in Annex C.

b) *Electrical durability*

The electrical durability of a control circuit device is verified, when needed, by a special test conducted at the discretion of the manufacturer. Instructions for conducting this test are given in Annex C.

7.2.5 Conditional short-circuit current

The switching element shall withstand the stresses resulting from short-circuit currents under the conditions specified in 8.3.4.

7.2.6 Switching overvoltage

Subclause 7.2.6 of IEC 60947-1 applies.

7.2.7 Additional requirements for control switches suitable for isolation

Control switches suitable for isolation shall be tested according to 8.3.3.4 of IEC 60947-1 with a value of test voltage as specified in Table 14 of IEC 60947-1 corresponding to the rated impulse withstand voltage U_{imp} declared by the manufacturer.

Other additional requirements applicable to such control switches are under consideration.

7.3 Electromagnetic compatibility (EMC)

Subclause 7.3 of IEC 60947-1 applies unless otherwise specified in this standard.

Table 4 – Verification of making and breaking capacities of switching elements under normal conditions corresponding to the utilization categories¹⁾

Table 4a

Utilization category	Make ²⁾			Break ²⁾			Minimum on-time
	I/I_e	U/U_e		I/I_e	U/U_e		
AC			$\cos \varphi$			$\cos \varphi$	Cycles (at 50 Hz or 60 Hz)
AC-12	1	1	0,9	1	1	0,9	2
AC-13	2	1	0,65	1	1	0,65	2 ³⁾
AC-14	6	1	0,3	1	1	0,3	2 ³⁾
AC-15	10	1	0,3	1	1	0,3	2 ³⁾
DC			$T_{0,95}$ ms			$T_{0,95}$ ms	Time ms
DC-12	1	1	1	1	1	1	25
DC-13	1	1	$6 \times P^6)$	1	1	$6 \times P^6)$	$T_{0,95}$
DC-14	10	1	15	1	1	15	25 ³⁾

Table 4b

Sequence, number and rate of operations		
Order ⁷⁾	Number	Rate per minute
1	50 ⁴⁾	6
2	10	Rapidly ⁵⁾
3	990	60
4	5 000	6

 I_e Rated operational current I Current to be made or broken U_e Rated operational voltage U Voltage before make $P = U_e \times I_e$ Steady-state power consumption, in W $T_{0,95}$ Time to reach 95 % of the steady-state current

1) See 8.3.3.5.2.

2) For tolerances on test quantities, see 8.3.2.2.

3) Both on-time values (for /make and for /break) shall be at least equal to 2 cycles (or 25 ms for DC-14).

4) The first 50 operating cycles shall be made with the test voltage raised to $U_e \times 1,1$, the test current I_e having been first set with the voltage at U_e .

5) As rapidly as possible whilst ensuring complete closing and opening of contacts.

6) The value $6 \times P$ results from an empirical relationship which is found to represent most d.c. magnetic loads to an upper limit of $P = 50$ W, i.e. $6 \times P = 300$ ms. Loads having power consumption greater than 50 W are assumed to consist of smaller loads in parallel. Therefore, 300 ms is to be an upper value, irrespective of the power.

7) For all utilization categories the test sequence shall be in the order given.

8 Tests

8.1 Kinds of test

8.1.1 General

Subclause 8.1.1 of IEC 60947-1 applies.

8.1.2 Type tests

Type tests are intended to verify compliance of the designs of the control circuit devices with this standard.

They comprise the verification of:

- a) temperature-rise (8.3.3.3);
- b) dielectric properties (8.3.3.4);
- c) making and breaking capacities of switching elements under normal conditions (8.3.3.5.2);
- d) making and breaking capacities of switching elements under abnormal conditions (8.3.3.5.3);
- e) performance under conditional short-circuit current (8.3.4);
- f) constructional requirements (8.2);
- g) degree of protection of enclosed control circuit devices (8.3.1).

8.1.3 Routine tests

Routine tests are the responsibility of the manufacturer and are usually limited to a mechanical inspection and a verification of the mechanical operation.

In certain cases specified in Annexes J and K, the inspection is supplemented by a dielectric test.

When performed, the dielectric test is carried out according to 8.3.3.4 with the following amendments: the required minimum duration of voltage application is reduced to about 1 s and the metal foil and external terminal connections are unnecessary.

Additional routine tests for the control switch or the control circuit device may be specified as appropriate. A sampling plan may be accepted.

8.1.4 Sampling tests

Sampling tests shall be performed on time delay devices to verify the time delay or range of time delay as stated by the manufacturer.

NOTE Sampling tests for clearance verification, according to 8.3.3.4.3 of IEC 60947-1 are under consideration.

8.1.5 Special tests

These tests are subject to agreement between manufacturer and user.

They comprise the verification of the durability (see Annex C).

The mechanical and electrical durability tests shall be performed with the actuator operated by a machine that complies with the requirements of 8.3.2.1.

8.2 Compliance with constructional requirements

Subclause 8.2 of IEC 60947-1 applies except for 8.2.5 and 8.2.6.

8.2.5 Verification of actuating force (or moment)

When required in 7.1.4.3, the minimum actuating force or moment shall be tested during sequence V of 8.3.1. The performance shall be as stated in 7.1.4.3.

8.2.6 Verification of limitation of rotation (of a rotary switch)

When this test is required in 7.1.4.4, it shall be tested during sequence VI of 8.3.1. The test sample shall be mounted according to the manufacturer's instructions.

The operation moment shall be measured five times and the maximum value recorded. The maximum moment value, multiplied by five, shall be applied to the actuator by forcing it against the means of limitation. The moment shall be applied for 10 s.

The test is passed if the means of limitation has not moved, become loose or prevented the actuator's normal operation.

8.3 Performance

8.3.1 Test sequences

The type and sequence of tests to be performed on representative samples are as follows.

- **Test sequence I** (sample No. 1)
 - Test No. 1 – Operating limits of contactor relays (8.3.3.2), if applicable
 - Test No. 2 – Temperature rise (8.3.3.3)
 - Test No. 3 – Dielectric properties (8.3.3.4)
 - Test No. 4 – Mechanical properties of terminals (8.2.4 of IEC 60947-1)
- **Test sequence II** (sample No. 2)
 - Test No. 1 – Making and breaking capacities of switching elements under normal conditions (8.3.3.5.2)
 - Test No. 2 – Dielectric verification (8.3.3.5.5 b))
- **Test sequence III** (sample No. 3)
 - Test No. 1 – Making and breaking capacities of switching elements under abnormal conditions (8.3.3.5.3)
 - Test No. 2 – Dielectric verification (8.3.3.5.5 b))
- **Test sequence IV** (sample No. 4)
 - Test No. 1 – Performance under conditional short-circuit current (8.3.4)
 - Test No. 2 – Dielectric verification (8.3.3.5.5 b))
- **Test sequence V** (sample No. 5)
 - Test No. 1 – Degree of protection of enclosed control circuit devices (Annex C of IEC 60947-1)
 - Test No. 2 – Verification of actuation force or moment (8.2.5)

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– Test sequence VI (sample No. 6)

Test No. 1 – Measurement of clearances and creepage distances, if applicable (7.1.3)

Test No. 2 – Verification of limitation of rotation of a rotary switch (8.2.6).

There shall be no failure in any of the above tests.

More than one test sequence or all test sequences may be conducted on one sample at the request of the manufacturer. However, the tests shall be conducted in the sequence given for each sample above.

NOTE For class II control circuit devices insulated by encapsulation, additional samples are required (see Annex F). For control circuit devices with integrally connected cables, see Annex G.

8.3.2 General test conditions

8.3.2.1 General requirements

Subclause 8.3.2.1 of IEC 60947-1 applies with the following addition:

The tests shall be performed with the actuator operated by a machine complying with the requirements of 8.3.2.1 a) or, for a rotary switch, in accordance with 8.3.2.1 b).

- a) For push-buttons and/or related control switches the operating machine shall apply the actuating force (or moment) to the actuator in the direction of its motion.

The force (or moment) or the travel of the operating machine shall comply with one of the following conditions according to the manufacturer's instructions:

- the maximum force (or moment) exerted on the actuator shall not exceed 1,5 times the force (or moment) required for maximum over-travel of the contact element(s);
- the cover-travel of the contact elements shall be between 50 % and 80 % of the over-travel inherent in the design of the contact elements.

During the whole part of the operating cycle where the contacts move from the open to closed position (or vice versa) or at least at the moment when the switching operation occurs, the velocity of the operating machine, measured where it touches the actuator, shall be between 0,05 m/s and 0,15 m/s.

The mechanical connection between the operating machine and the actuator shall have a sufficient free play (lost motion) to avoid the operating machine impeding the free motion of the actuator away from it.

- b) For switches fully rotary in both directions, one operating cycle comprises either one fully clockwise operation of the actuator or one fully anticlockwise operation of the actuator. However, in this case approximately three-quarters of the total number of operating cycles shall be made in the clockwise direction, followed by the remainder in the anticlockwise direction. The angular velocity shall be between 0,5 to 1 revolution per second.

8.3.2.2 Test quantities

Subclause 8.3.2.2 of IEC 60947-1 applies except for 8.3.2.2.3.

8.3.2.3 Evaluation of test results

The condition of the control circuit device after each test shall be checked by the verifications applicable to each test.

A control circuit device is deemed to have met the requirements of this standard if it meets the requirements of each test and/or test sequence as applicable.

8.3.2.4 Test reports

Subclause 8.3.2.4 of IEC 60947-1 applies.

8.3.3 Performance under no-load, normal load and abnormal load conditions

8.3.3.1 Operation

Subclause 8.3.3.1 of IEC 60947-1 applies.

8.3.3.2 Operating limits of contactor relays

The operating limits of contactor relays shall be in accordance with the standard applicable to contactors (see IEC 60947-4-1).

8.3.3.3 Temperature rise

Subclause 8.3.3.3 of IEC 60947-1 applies with the following addition:

All switching elements of the control circuit device shall be tested. All switching elements that may be simultaneously closed shall be tested together. However, switching elements forming an integral part of an actuating system in such a manner that the elements cannot remain in the closed position are exempt from this test.

NOTE Several temperature-rise tests may be necessary if the control circuit device has several positions in which switching elements are in their closed position.

The minimum length of each temporary connection, from terminal to terminal, shall be 1 m.

8.3.3.4 Dielectric properties

Subclause 8.3.3.4 of IEC 60947-1 applies with the following addition.

For Class II control circuit devices insulated by encapsulation, see Annex F.

8.3.3.4.1 Type tests

Subclause 8.3.3.4.1 of IEC 60947-1 applies with the following addition.

Add, after the second paragraph of 3) c):

The control circuit device shall be capable of withstanding the test voltage applied as follows:

- between live parts of the switching element and parts of the control switch intended to be earthed;

- between live parts of the switching element and surfaces of the control switch likely to be touched in service, conductive or made conductive by a metal foil;
- between live parts belonging to electrically separated switching elements.

8.3.3.5 Making and breaking capacities

Tests for verification of making and breaking capacities shall be made according to the general test requirements stated in 8.3.2.1.

8.3.3.5.1 Test circuits and connections

Tests shall be carried out on a single-pole element or on one pole of a multi-pole device provided that all pole elements are identical in construction and operation.

Adjacent contact elements are considered to be of the opposite polarity unless otherwise stated by the manufacturer.

Change-over contacts of forms C and Za are of the same polarity and change-over contacts of form Zb are of the opposite polarity.

Single-pole elements or contact elements in a multi-pole device stated as the same polarity shall be connected in accordance with the circuit shown in Figure 5. Any adjacent contact elements not being tested shall not be connected.

Change-over contacts of forms C and Za shall be subject to separate tests in the normally open and normally closed positions connected in accordance with Figure 5.

Contact elements of the opposite polarity shall be connected in accordance with the circuit shown in Figure 6. Adjacent contact elements of the opposite polarity not being tested shall be jointly connected to the supply, as shown.

Change-over contacts of form Zb shall be subject to separate tests in the normally open and normally closed positions but with both terminals of the opposite position being connected to the supply, as shown in Figure 6, for an adjacent contact of opposite polarity.

If the make and break operations require different values, the circuit shown in Figure 7 shall represent load L_d in Figures 5 and 6.

For a.c. tests:

The load shall be an air-cored inductor in series with a resistor, if needed, to obtain the specified power factor. The inductor shall be shunted by a resistor taking 3 % of the total power consumed (see Figure 7).

For d.c. tests:

To obtain the specified steady-state current the test current shall increase from zero to the steady-state value within the limits shown in Figure 9. For guidance, an example of an iron-cored load is shown in Annex B.

Test voltage and test current shall be in accordance with Tables 4 and 5. The test circuit applied shall be stated in the test report.

8.3.3.5.2 Making and breaking capacities of switching elements under normal conditions

The tests are intended to verify that the control circuit device is capable of performing its intended duty according to the utilization category.

With the load set in accordance with Table 4, the 6 050 operating cycles shall be carried out in the following sequence:

- 50 operations at 10 s intervals with the voltage set at $1,1 U_n$;
- 10 operations as rapidly as possible whilst ensuring complete closing and opening of contacts;
- 990 operations at 1 s intervals;
- 5 000 operations at 10 s intervals.

When the construction of the device is such that rapid cycling is not possible, for example overload relay contacts, the operations shall be at 10 s intervals or as fast as the device will permit.

For auxiliary contacts of a switching device, for example contactor, circuit-breaker, the number of operating cycles shall be the same as that required for the verification of the conventional operational performance capability of the switching device (see appropriate product standard).

8.3.3.5.3 Making and breaking capacities of switching elements under abnormal conditions

The test is intended to verify that the control circuit device is capable of making and breaking currents associated with electromagnetic loads. Load values, together with the sequence of operations shall be in accordance with Table 5.

8.3.3.5.4 Vacant

8.3.3.5.5 Results to be obtained

- a) During the tests of 8.3.3.5.2 and 8.3.3.5.3 there shall be no electrical or mechanical failures, no contact welding or prolonged arcing, and the fuses shall not blow.
- b) After the test of 8.3.3.5.2 and 8.3.3.5.3 the device shall withstand the power-frequency test voltage of $2 U_n$, but not less than 1 000 V, applied as specified in 8.3.3.4.1.

8.3.4 Performance under conditional short-circuit current

8.3.4.1 General conditions for short-circuit tests

The switching element shall be in a new and clean condition, mounted as in service.

8.3.4.2 Test procedure

The switching element may be operated several times before the test, at no load or at any current not exceeding the rated current.

A contact element with two terminals shall be tested with the actuator in the position corresponding to the closed position of the switching element under test.

The contact element to be tested shall be in series with the short-circuit protective device (SCPD), the load impedance, and a separate switching device in a single-phase circuit as shown in Figure 8. The test quantities shall be in accordance with 8.3.4.3.

The test is performed by making the current with the separate making switch and the current shall be maintained until the SCPD operates.

The test shall be performed three times on the same contact element, the SCPD being reset or replaced after each test. The time interval between the tests shall be not less than 3 min. The actual time interval shall be stated in the test report.

For change-over contact elements, the above test shall be made separately on both the normally closed and normally open contacts.

NOTE For control switches with both two terminals and change-over contact elements, both types should be tested.

A separate control circuit device may be used for each contact element.

8.3.4.3 Test circuit and test quantities

The switching element shall be connected in series with the short-circuit protective device of type and rating stated by the manufacturer; it shall also be in series with the switching device intended to close the circuit.

The test circuit load impedance shall be an air-cored inductor in series with a resistor, adjusted to a prospective current of 1 000 A, or a higher value, if stated by the manufacturer, at a power factor of between 0,5 and 0,7 and at the rated operational voltage. No parallel damping load shall be added. The open circuit voltage shall be 1,1 times the maximum rated operational voltage of the switching element.

The switching element shall be connected in the circuit using 1 m total length of cable corresponding to the operational current of the switching element.

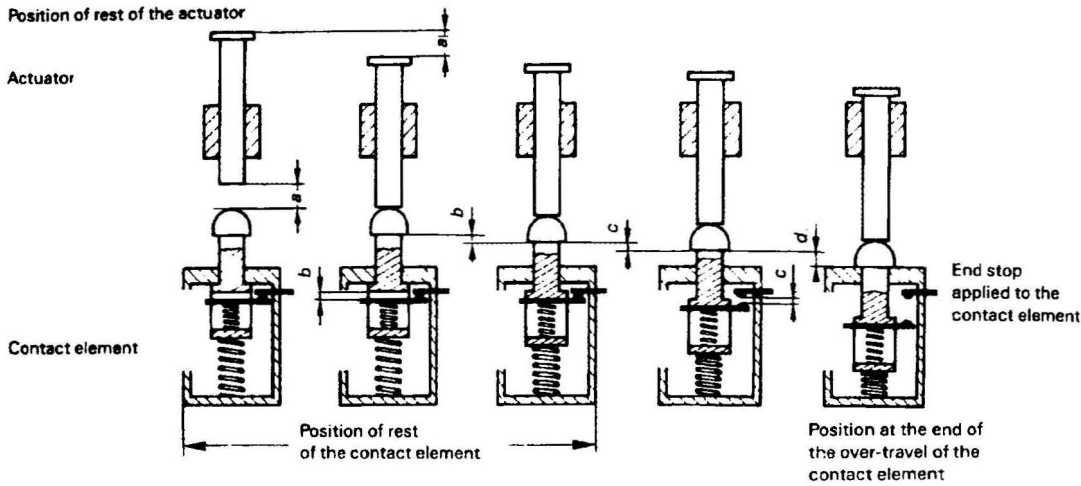
8.3.4.4 Condition of the switching element after the test

- a) After the short-circuit test it shall be possible to open the switching elements by the normal actuating system.
- b) After the test the device shall withstand the power-frequency voltage of $2 U_n$ but not less than 1 000 V applied as specified in 8.3.3.4.1.

Number of the example	Disposition of the contact element(s)	Actuator positions					
		1	2	3	4	5	
1		x					Contact element closed in actuator position No. 1 only.
2			x		x	x	Contact element closed in actuator positions No. 2, 4 and 5.
3			x				Two contact elements used as change-over contact elements with 3 terminals.
					x		
4			x				Contact element with pulse (fleeting) contact closed between actuator positions No. 2 and 3.
5		x	x		x	x	Contact element with pulse (fleeting) contact open between actuator positions No. 3 and 4.
6					x	x	Contact element with maintained contact between actuator positions No. 4 and 5.
7		x					Two contact elements with close-before-open contacts between actuator positions No. 1 and 2.
			x				
8		x					Two contact elements with open-before-close contacts between actuator positions No. 1 and 2 (*).
			x				
9	A	x		x			Operation in which contact element B is arranged to close before and open after contact element A.
	B	x		x			

(*) Open-before-close contact elements may be used to break the current in one circuit before making the current in the other circuit, provided the time interval be properly related to the circuit conditions.

Figure 1 – Examples of the recommended method for drawing an operating diagram of a rotary switch



- a Pre-travel of the actuator
- b Pre-travel of the contact element
- c Minimum value required to give adequate contact gap
- d Over-travel of the contact element

$b + c + d$ Total travel of the contact element

$a + b + c + d + e)^*$ Total travel of the actuator

*NOTE Because of a possible resilient connection between the actuator and the contact element (for example, see Figure 3), the over-travel of the actuator may exceed the over-travel of the contact element by a length e .

Figure 2 – Operation of push-buttons

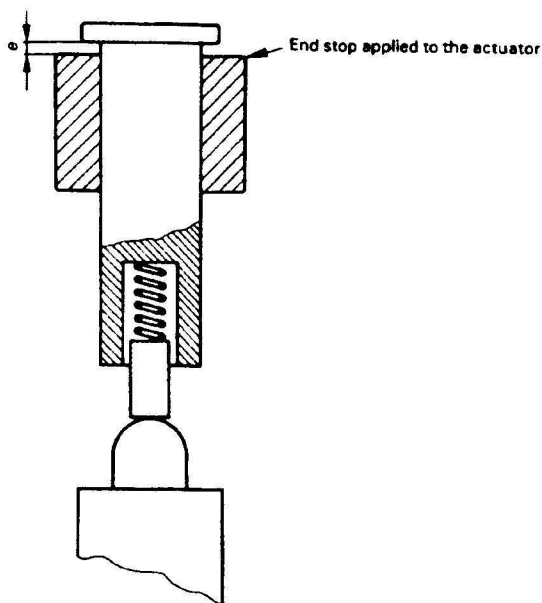


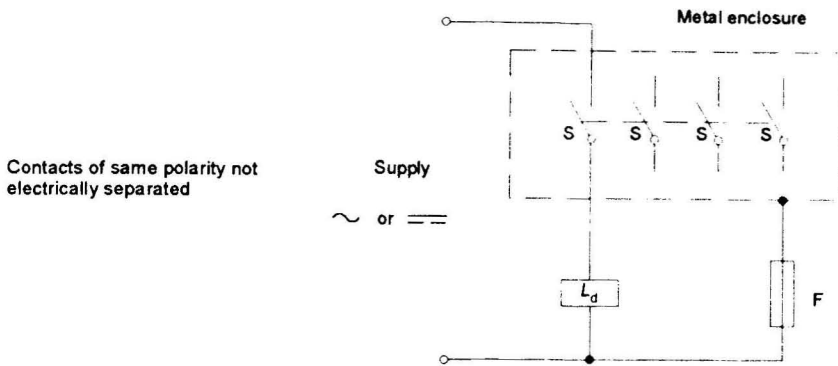
Figure 3 – Difference e between the over-travel of the actuator and that of the contact element

Figure No.	Figure	Symbols	Forms	Description
4a)		 Note 1	A	Single gap contact element with two terminals
		 Note 1	B	
4b)		 Note 1	X	Double gap contact element with two terminals
		 Note 1	Y	
4c)		 Note 1	C	Change-over, single gap, contact element with three terminals
4d)			Za	Change-over, double gap, contact element with four terminals Note – The contacts are of the same polarity
4e)			Zb	Change-over, double gap, contact element with four terminals (The two moving contacts are electrically separated)

NOTE 1 Symbols according to IEC 60617.

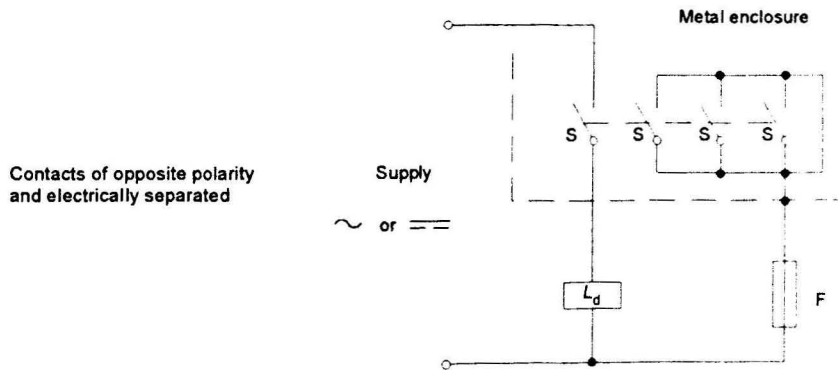
Figure 4 – Examples of contact elements (schematic sketches)

Test circuits
(see 8.3.3.5)
Multi-pole control switches



- L_d : Load according to Figure 7
F: Fuse or isolation measurement device
S: Contact element (NO or NC)

**Figure 5 – Test circuits for multi-pole control switches –
Contacts of same polarity, not electrically separated**



- L_d : Load according to Figure 7
F: Fuse or isolation measurement device
S: Contact element (NO or NC)

**Figure 6 – Test circuits for multi-pole control switches –
Contacts of opposite polarity, and electrically separated**

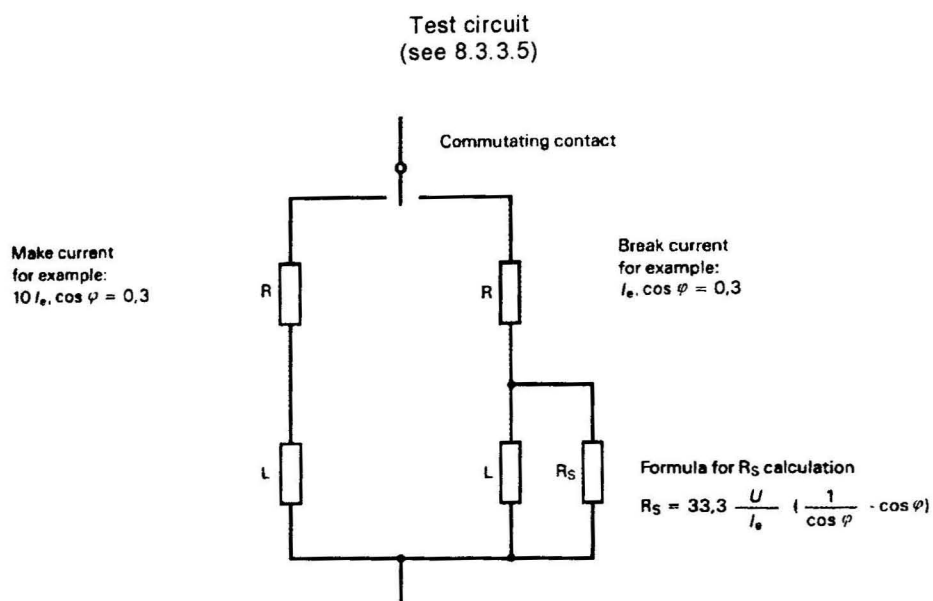
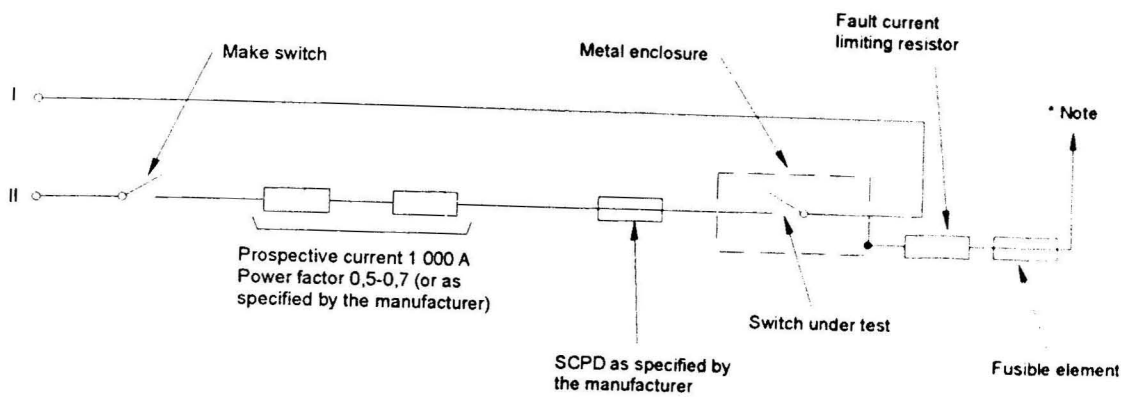


Figure 7 – Load L_d details for test conditions requiring different values of make and break current and/or power factor (time constant)



NOTE To be connected alternatively to I or II on successive tests.

Figure 8 – Test circuit, conditional short-circuit current (see 8.3.4.2)

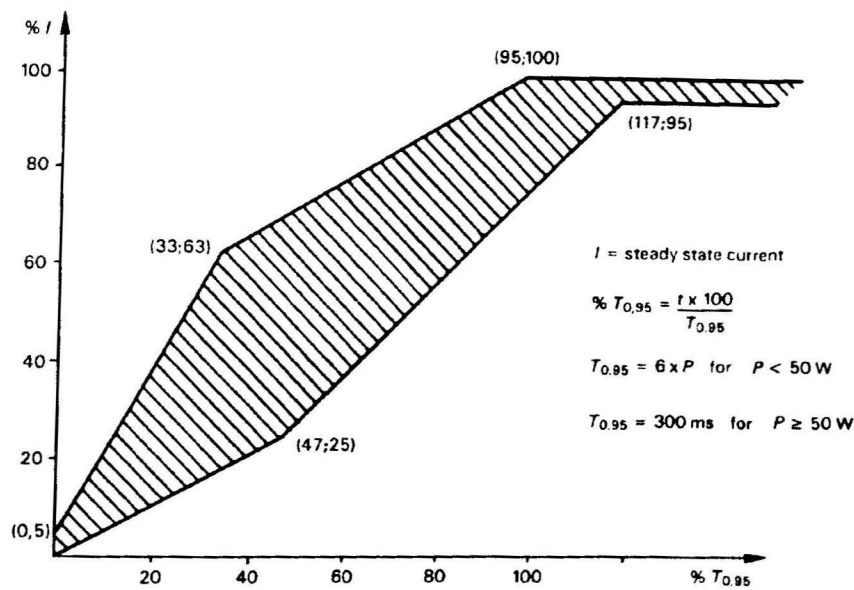


Figure 9 – Current/time limits for d.c. test loads (see 8.3.3.5.3)

Annex A

(normative)

Electrical ratings based on utilization categories

(see 3.1)

Table A.1 – Examples of contact rating designation based on utilization categories

Designation ¹⁾	Utilization category	Conventional enclosed thermal current I_{the} A	Rated operational current I_e (A) at rated operational voltage U_e						VA rating	
			120 V	240 V	380 V	480 V	500 V	600 V	M	B
Alternative current										
A150	AC-15	10	6	—	—	—	—	—	7 200	720
A300	AC-15	10	6	3	—	—	—	—	7 200	720
A600	AC-15	10	6	3	1,9	1,5	1,4	1,2	7 200	720
B150	AC-15	5	3	—	—	—	—	—	3 600	360
B300	AC-15	5	3	1,5	—	—	—	—	3 600	360
B600	AC-15	5	3	1,5	0,95	0,75	0,72	0,6	3 600	360
C150	AC-15	2,5	1,5	—	—	—	—	—	1 800	180
C300	AC-15	2,5	1,5	0,75	—	—	—	—	1 800	180
C600	AC-15	2,5	1,5	0,75	0,47	0,375	0,35	0,3	1 800	180
D150	AC-14	1,0	0,6	—	—	—	—	—	432	72
D300	AC-14	1,0	0,6	0,3	—	—	—	—	432	72
E150	AC-14	0,5	0,3	—	—	—	—	—	216	36
Direct current			125 V	250 V		400 V	500 V	600 V		
N150	DC-13	10	2,2	—		—	—	—	275	275
N300	DC-13	10	2,2	1,1		—	—	—	275	275
N600	DC-13	10	2,2	1,1		0,63	0,55	0,4	275	275
P150	DC-13	5	1,1	—		—	—	—	138	138
P300	DC-13	5	1,1	0,55		—	—	—	138	138
P600	DC-13	5	1,1	0,55		0,31	0,27	0,2	138	138
Q150	DC-13	2,5	0,55	—		—	—	—	69	69
Q300	DC-13	2,5	0,55	0,27		—	—	—	69	69
Q600	DC-13	2,5	0,55	0,27		0,15	0,13	0,1	69	69
R150	DC-13	1,0	0,22	—		—	—	—	28	28
R300	DC-13	1,0	0,22	0,1		—	—	—	28	28
									M = make B = break	

NOTE 1 The letter stands for the conventional enclosed thermal current and identifies (a.c. or d.c.): for example B means 5 A a.c. The rated insulation voltage U_i is at least equal to the number after the letter.

NOTE 2 The rated operational current I_e (A), the rated operational voltage U_e (V) and the break apparent power B (VA) are correlated by the formula $B = U_e \cdot I_e$.

**Table A.2 – Examples of semiconductors switching element ratings
for 50 Hz and/or 60 Hz ¹⁾**

Switching element rating Designation	Rated operational current I_o A	Rated make current A				Minimum operational current A	Maximum OFF-state current mA
		AC15	AC14	AC13	AC12		
SA	10	100	60	20	10	0,1	15
SB	5	50	30	10	5	0,1	15
SC	2	20	12	4	2	0,05	10
SD	1	10	6	2	1	0,05	10
SE	0,5	5	3	1	0,5	0,01	10
SF	0,25	2,5	1,5	0,5	0,25	0,01	5
SG	0,1	1	0,6	0,2	0,1	0,01	3

¹⁾ The rated operational voltage shall be specified by the manufacturer.

Table A.3 – Examples of semiconductors switching element ratings for d.c. ¹⁾

Switching element rating Designation	Rated operational current I_o A	Rated make current A			Maximum OFF-state current mA
		DC14	DC13	DC12	
SN	10	100	10	10	5
SP	5	50	5	5	4
SQ	2	20	2	2	4
SR	1	10	1	1	2
SS	0,5	5	0,5	0,5	2
ST	0,25	2,5	0,25	0,25	1
SU	0,1	1	0,1	0,1	0,4
SV	0,05	0,5	0,05	0,05	0,2

¹⁾ The rated operational voltage shall be specified by the manufacturer.

Annex B
(normative)

Example of inductive test loads for d.c. contacts

B.1 General

The direct current inductive loads found in control circuits are usually electromagnetically driven relays, contactors and solenoids with solid iron loads rated 50 W or less. The influence of these loads on the contacts of the control circuit device is determined by the stored energy of the inductor which, in turn, is related to the average rate of rise of the current in the inductor or to the charging time of the inductor.

It has been empirically determined that inductive loads up to 50 W almost always have a charging time ($T_{0,95}$) to 95 % of their full current value of 6 ms per watt or less.

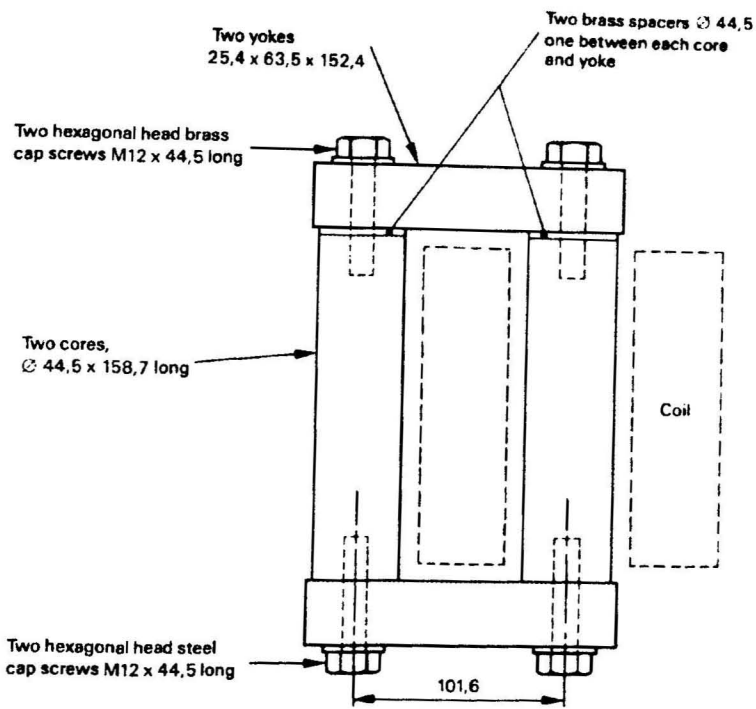
B.2 Construction

The following inductive test loads may be used to approximate the loads imposed upon contacts used in d.c. control circuits:

The magnetic circuit consists of two solid steel cores, 44,5 mm in diameter and 158,7 mm long, which are fastened by screws at each end to solid steel yokes 25,4 mm × 63,5 mm × 152,4 mm on 101,6 mm centres (see Figure B.1). The steel has a resistance of between 13,3 and 19,9 $\mu\Omega/\text{cm}$. (Cold-finished low carbon steels such as AISI 1010, 1015, 1018 or 116 equivalent meet this requirement.) At one end of each core, a non-magnetic spacer having a thickness adjustable to between 0,127 mm and 0,762 mm is interposed between the end of the core and the yoke. Non-magnetic screws shall be used to hold the yoke at the end having the non-magnetic spacer, and steel screws shall be used at the other end.

A coil having the winding characteristics shown in Figure B.1 surrounds one of the cores. The current in the coil, when energized at the test voltage, is adjusted to the value specified in the Table B.1 by means of a series resistor.

The thickness of the spacer is adjusted so that the coil current builds up from zero to 95 % of its full value within the limits shown in Figure 9. If the current curve falls below the minimum time limit, the cross section of the iron yoke is increased and if it falls above the maximum limit the cross section is reduced.



Dimensions in millimetres

Figure B.1 – Construction of load for d.c. contacts

Table B.1 – DC loads

Coil construction					
Test voltage V	Number of turns	Wire size mm ²	Approximate coil resistance Ω	Current limit with series resistor A	Wattage at test voltage W
125	7 000	0,52	74	1,1	138
250	14 000	0,26	295	0,55	138
600	33 400	0,10	1 680	0,20	120

Annex C
(normative)

Special tests – Durability tests

C.1 General

C.1.1 Durability declaration

The special durability tests (see 7.2.4.3) described in this annex are conducted at the discretion of the manufacturer. If the manufacturer declares a mechanical and/or electrical durability, the value shall correspond to the special tests described respectively in C.2 and/or C.3.

NOTE Both durability types apply to the complete control circuit device.

Both durability types are expressed as a number of operating cycles (see C.2.1 and/or C.3.1).

The preferred numbers of operating cycles declared for any type of durability are the following: 0,01 – 0,03 – 0,1 – 0,3 – 1 – 3 – 10 – 30 or 100 millions.

C.1.2 Test procedures

C.1.2.1 General

Every test shall be performed under the general conditions stated in 8.3.2.1, and at a rate equal or higher than that declared by the manufacturer. The moving parts of the device shall reach their maximum operating positions in both directions, as recommended by the manufacturer.

The test results are verified by statistical analysis according to the *single 8* (see C.1.2.2) or *double 3* (see C.1.2.3) test methods.

The manufacturer may declare mechanical durability based on experience with similar design.

NOTE The *single 8* or *double 3* test methods are both given in IEC 60410 (see Tables X-C-2 and X-D-2). These two tests have been chosen with the objective of testing a limited number of control circuit devices on the same statistical characteristics (acceptance level: 10 %). Other methods providing the 10 % acceptance level may be used.

C.1.2.2 Single 8 test

Eight control circuit devices shall be tested to the declared number of operating cycles.

If the number of failed devices does not exceed two, the test is considered passed.

C.1.2.3 Double 3 test

Three control circuit devices shall be tested to the declared number of operating cycles.

The test is considered passed if there is no failure, and failed if there is more than one failure. Should there be only one failure, then three additional control circuit devices are tested to the declared number of operating cycles and providing there is no additional failure, the test is considered passed.

C.1.3 Failure criteria

During the tests described in C.2.2 and C.3.2, there shall be no electrical and/or mechanical failures. Following the tests, the switching element shall pass the dielectric test of 8.3.3.4 with a rated test voltage equal to $2 U_e$ with a minimum of 1.000 V.

C.2 Mechanical durability

C.2.1 General

The mechanical durability of a control circuit device is defined as the number of no-load operating cycles which will be attained or exceeded by 90 % of all devices tested without repair or replacement of any part.

C.2.2 Test procedures

Tests are carried out according to C.1.2.

During the test, periodically the contacts shall be checked at any voltage and current, selected by the manufacturer, and there shall be no failure (see C.1.3).

C.3 Electrical durability

C.3.1 General

The electrical durability of a control circuit device is defined as the number of on-load operating cycles which will be attained or exceeded by 90 % of all devices tested, without repair or replacement of any part.

C.3.2 Test procedures

Electrical durability tests are carried out by operating the device under the conditions defined in Table C.1, in accordance with C.3.2.1 for a.c. or with C.3.2.2 for d.c.

Each mechanical operating cycle shall include an interruption of test current.

The ON-duration of current shall be not more than 50 % and not less than 10 % of an operating cycle. If the test circuit shown in Figure C.1 is used, the ON-duration of current at ten times I_e shall not cause overheating.

Alternatively these tests may be performed on the actual load for which the control switch is intended.

Table C.1 – Making and breaking conditions for electrical durability

Kind of current	Utilization category	Make			Break		
Alternating	AC-15	I	U	$\cos \varphi$	I	U	$\cos \varphi$
		$10 I_e$	U_e	0,7 ¹⁾	I_e	U_e	0,4 ¹⁾
Direct ²⁾	DC-13	I	U	$T_{0,95}$	I	U	$T_{0,95}$
		I_e	U_e	$6 \times P^{3)}$	I_e	U_e	$6 \times P^{3)}$
I_e Rated operational current I Current to be made or broken							
U_e Rated operational voltage U Voltage							
$P = U_e \times I_e$ Steady-state power consumption, in W $T_{0,95}$ Time to reach 95 % of the steady-state current, in milliseconds							
<div>1) The power-factors indicated are conventional values and apply only to the test circuits which simulate the electrical characteristics of coil circuits. It should be noted that, for circuits with power-factor 0,4, shunt resistors are used in the test circuit to simulate the damping effect on the eddy current losses of the actual electromagnet.</div> <div>2) For d.c. electromagnetic loads provided with switching devices introducing an economy resistor, the rated operational current shall be at least equal to the maximum value of the inrush current.</div> <div>3) The value "$6 \times P$" results from an empirical relationship which is found to represent most d.c. magnetic loads to an upper limit of $P = 50$ W, i.e. $6 \times P = 300$ ms. Loads having power consumption greater than 50 W are assumed to consist of smaller loads in parallel. Therefore, 300 ms is to be an upper value, irrespective of the power.</div>							

C.3.2.1 AC tests

The circuit to be used shall be as shown in Figure C.1 below, comprising

- a making circuit, consisting of an air-cored inductor, in series with a resistor, having a power factor of 0,7 and drawing a current of $10 I_e$;
- a breaking circuit, consisting of an air-cored inductor in series with a resistor, the whole being in parallel with a resistor in which flows about 3 % of the breaking current I_e , so that the total power factor be of 0,4.

If the contact element has a bounce time less than 3 ms, the test may be made with the simplified circuit shown in Figure C.2.

The test report shall record which test circuit has been used.

C.3.2.2 DC tests

Circuits to be used shall consist of:

- a) an air-cored inductor in series with a resistor.

A resistor shall be connected across the complete test circuit to simulate the damping due to eddy currents; the resistance value shall be such that 1 % of the test current will pass through this resistor; or,

- b) an iron-cored inductor, in series with a resistor, if required, to obtain a duration $T_{0,95}$ as indicated in Table C.1.

It shall be verified, by oscillograms, that the time to reach 95 % of the steady-state current is equal to the value given in Table C.1 ± 10 %, and the time to reach 63 % of the steady-state current is one-third of the value given in Table C.1 ± 20 %.

AC test circuits (see C.3.2.1)

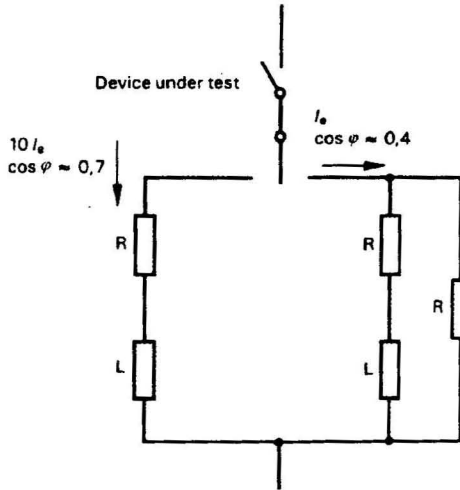


Figure C.1 – Normal circuit
(see C.3.2.1)

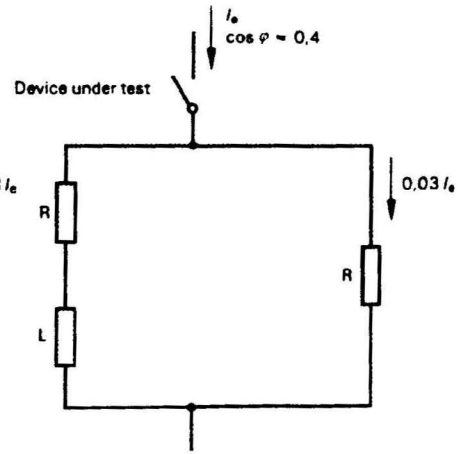


Figure C.2 – Simplified circuit
(see C.3.2.1)

Annex D
(normative)

Clearances and creepage distances of control circuit devices

D.1 Scope

The recommendations of this annex apply to control circuit devices specified in this standard. They apply to equipment in air and to normal atmospheric conditions as defined in 6.1.3.2. When the atmospheric conditions differ from the normal, this should be recognized either by the choice of enclosures or by larger creepage distances. Observation of these recommendations does not imply that the devices will meet the test requirements of this standard.

They apply neither to devices for which a value of U_{imp} has been declared, nor to devices suitable for isolation which shall comply with the requirements of 7.1.3.

D.2 Definitions

(Vacant)

D.3 General

D.3.1 It is recommended that the surface of the insulating parts should be designed with ridges so arranged as to break the continuity of conductive deposits which may form.

D.3.2 The recommended clearances and creepage distances apply to non-arcing parts. In the vicinity of arcs or in areas where ionized gases may be present, the normal atmospheric conditions defined in 6.1.3.2 do not exist and larger values may be necessary.

D.3.3 The recommended clearances do not apply to the gap between the separable contacts of the same pole when in the open position.

D.3.4 Conducting parts covered only with varnish or enamel, or protected only by oxidation or a similar process, should not be considered as being insulated.

D.3.5 The recommended clearances and creepage distances shall be maintained under the following circumstances:

- a) on the one hand, without external electrical connections, on the other hand, when insulated or bare conductors of the type and of any dimensions specified for the contactor are installed according to the manufacturer's instructions, if any;
- b) after interchangeable parts have been changed, taking into account maximum permissible manufacturing tolerances;
- c) taking into consideration possible deformation due to the effect of temperature, ageing, shocks, vibration, or due to short-circuit conditions which the contactor is intended to endure.

D.4 Determination of clearances and creepage distances

In determining clearances and creepage distances, it is recommended that the following points should be considered:

D.4.1 If a clearance or a creepage distance is influenced by one or more metal parts, either one of the sections between these parts should have at least the prescribed minimum value, or the sum of the two largest sections should have at least 1,25 times the prescribed minimum value. Individual sections less than 2 mm in length should not be taken into consideration in the calculation of the total length of clearances and creepage distances.

D.4.2 In determining a creepage distance, grooves at least 2 mm wide and 2 mm deep should be measured along their contour. Grooves having any dimension less than these dimensions and any groove liable to be clogged with dirt should be neglected and direct distance only measured.

D.4.3 In determining a creepage distance, ridges less than 2 mm high should be neglected. Those at least 2 mm high:

- are measured along their contour, if they are an integral part of a component in insulating material (for instance by moulding or welding);
- are measured along the shorter of two paths: length of joint or profile of ridge, if they are not an integral part of a component in insulating material.

D.4.4 The application of the foregoing recommendations is illustrated by examples 1 to 11 of Annex G of IEC 60947-1.

D.5 Minimum values of clearances and creepage distances

D.5.1 The values of clearances and creepage distances are given in Table D.1 as a function of rated insulation voltage and of the conventional thermal current I_{th} of the control circuit device.

D.5.2 The values of clearances are given between two live parts (L-L) and between a live part and an exposed conductive part (L-A). The distance between a live part and an earthed part (which is not an exposed conductive part) may be that specified for L-L for the corresponding voltage.

D.5.3 The values of creepage distances also depend on the insulating material and the shape of the insulating piece.

Column a: 1) Ceramics (steatite, porcelain).

2) Other kinds of insulating materials designed with ridges or with approximately vertical surfaces, for which experience has shown that they are capable of giving satisfactory service with the creepage distances used for ceramics.

NOTE Such materials may be materials having a comparative tracking index of at least 140 V (see IEC 60112) for example phenolic mouldings.

Column b: All other cases.

The values in Table D.1 are given only as a guide to what may be regarded as minimum values.

Table D.1 – Clearances and creepage distances

Rated insulation voltage U_1 V	Clearances mm		Creepage distances mm	
	L-L	L-A	a	b
$U_1 \leq 60$	2	3	2	3
$60 < U_1 \leq 250$	3	5	3	4
$250 < U_1 \leq 400$	4	6	4	6
$400 < U_1 \leq 500$	6	8	6	10
$500 < U_1 \leq 690$	6	8	8	12
$690 < U_1 \leq 750$ c.a.	10	14	10	14
$750 < U_1 \leq 1\,000$ c.a.	14	20	14	20
<p>NOTE 1 The values in Table D.1 apply to the atmospheric conditions as specified in 6.1.3.2. For more severe conditions and for marine service, creepage distances should be at least those in column b.</p> <p>NOTE 2 When the clearance L-A is greater than the corresponding creepage distance specified in column a or column b, then the creepage distance from the live part to the exposed conductive part shall be not less than the clearance.</p>				

Annex E (normative)

Items subject to agreement between manufacturer and user

NOTE For the purpose of this annex:

- "agreement" is used in a very wide sense.
- "user" includes testing stations.

Annex J of IEC 60947-1 applies, as far as covered by clauses and of this standard, with the following additions:

Clause or subclause number of this standard	Item
5.2.5	Relationship between the positions of the actuator of rotary switches and the associated contact element positions in the operating diagram (indication by the manufacturer)
5.2.6	Characteristics of the delay of time-delay contact elements with adjustable delay of contactors relays (indication by manufacturer)
6.1.1 (Annex K)	Choice of connecting conductors for position switches with direct opening action
8.3.1	Test sequences made on one sample only (at the manufacturer's request)
8.3.4.3	Conditional short-circuit current test: <ul style="list-style-type: none"> – adjustment of the test circuit if the prospective current is different from 1 000 A (to be specified by the manufacturer) – power factor of the test circuit less than 0,5 (with the manufacturer's consent)

Annex F
(normative)

Class II control circuit devices insulated by encapsulation
Requirements and tests

F.1 General

This annex specifies constructional requirements and tests for class II control circuit devices or parts of devices in which insulation of class II according to IEC 61140 is achieved by encapsulation.

All non-encapsulated parts shall have clearances and creepage distances double to those specified in 7.1.3.

F.2 Definitions

For the purposes of this annex, the following definitions apply:

F.2.1

encapsulation

process by which all components, conductors and ends of integral cables are encased in an insulating compound by suitable means such as embedding or potting

F.2.1.1

embedding

process of completely encasing electrical device(s) by pouring a compound over it (them) in a mould, and removing the encased device(s) from the mould after solidification of the compound

F.2.1.2

potting

embedding process in which the mould remains attached to the encased electrical device(s)

F.2.2

compound

thermosetting, thermoplastic, catalytically cured and elastomeric materials with or without fillers and/or additives, after their solidification

F.2.3

temperature range of the compound

the ambient temperature range stated in 6.1.1 of IEC 60947-1

F.5 Marking

Control devices according to this annex shall be marked with the following symbol



This symbol is 60417-2-IEC-5172.

F.7 Instructional and functional requirements

F.7.1 Choice of compound

The compound shall be chosen so that the encapsulated control devices comply with the tests defined in F.8.

F.7.2 Adhesion of the compound

The adhesion of the compound shall be sufficient to prevent the ingress of moisture between the compound and all encapsulated parts and to prevent movement of the encapsulated portion of the cable if any.

Compliance shall be verified by tests of F.8.1.2.5 and F.8.1.2.2.

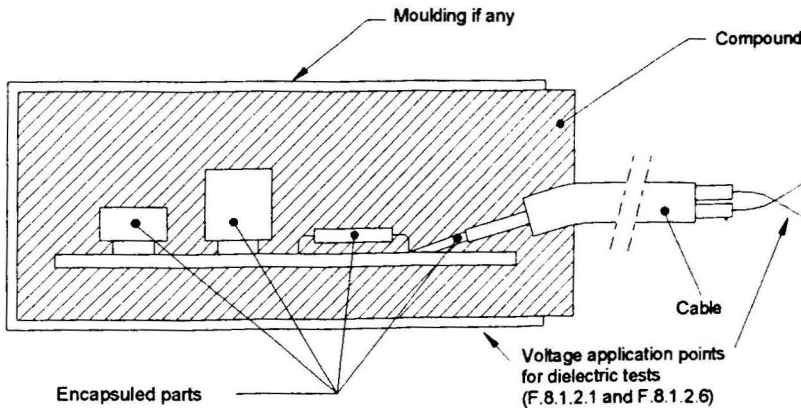


Figure F.1 – Insulation by encapsulation

F.7.3 Dielectric properties

Subclause 7.2.3 applies with the following changes.

For the verification of the impulse withstand voltage, the test voltage U_{imp} shall be the next higher category of the maximum rated operational voltage in the first column of Table H.1 of IEC 60947-1 for the stated overvoltage category.

For the verification of the power frequency withstand voltage, the test voltage shall be the sum of the voltage stated in Table 12A of IEC 60947-1 plus 1 000 V.

F.8 Tests

F.8.1 Kind of tests

F.8.1.1 General

Subclause 8.1.1 of IEC 60947-1 applies.

F.8.1.2 Type test

The following sequence of 6 tests shall be applied to each of 3 samples in the specified order.

F.8.1.2.1 Dielectric tests in new conditions

Subclause 8.3.3.4 of IEC 60947-1 applies with the exception that the values of voltages shall be applied between the stripped joined ends of the cable or the shorted terminals and any point of the surface (or metallic foil on the surface) of the encapsulated device (see Figure F.1). No breakdown of the insulation shall occur.

F.8.1.2.2 Cable tests (if applicable)

Control circuit devices provided with integrally connected cables shall comply with requirements of Annex G.

F.8.1.2.3 Rapid change of temperature test

Test Na shall be performed in accordance with IEC 60068-2-14 with the following values:

T_A and T_B are the minimum and the maximum temperatures stated in F.2.3

Transition time t_2 : 2 min to 3 min

Number of cycles: 5

Exposure time t_1 : 3 h

After the test no visible damage shall be observed.¹⁾

F.8.1.2.4 Impact test

The test is performed as follows (see Figure F.2). The sample is placed on a rigid support.

Three impacts of 0,5 J shall be applied near the centre of the largest surface or the longest axis (for cylindrical shape) of the encapsulated device.

The impacts are provided by dropping a steel ball of 0,25 kg from a height of 0,20 m.

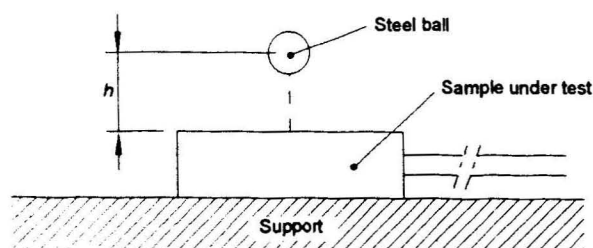


Figure F.2 – Test apparatus

The support is considered sufficiently rigid if its displacement under the impact energy is lower than 0,1 mm.

¹⁾ Small cracks of the moulding compounds, if any (see Figure F.1) are acceptable after tests F.8.1.2.3, F.8.1.2.4 and F.8.1.2.5. They shall not impair the results of the final test of F.8.1.2.6.

After test no visible damage shall be observed.¹⁾

F.8.1.2.5 Damp heat, cyclic

The test Db shall be performed according to IEC 60068-2-30 with the following values:

Upper temperature: 55 °C

Number of cycles: 6

The test report shall state which variant is applied: variant 1 or variant 2.

After the test no visible damage shall be observed.¹⁾

F.8.1.2.6 Dielectric test after stresses

Following Test F.8.1.2.5, the dielectric properties shall be checked by repeating tests specified in 8.3.3.4 with the test voltage of power-frequency withstand voltage being applied for 5 s.

The results to be obtained shall be as stated in 8.3.3.4 with the addition that the leakage current shall not exceed 2 mA at 1,1 U_i .

F.8.1.3 Routine tests

Subclause 8.1.3 applies but the dielectric test is mandatory.

¹⁾ Small cracks of the moulding compounds, if any (see Figure F.1) are acceptable after tests F.8.1.2.3, F.8.1.2.4 and F.8.1.2.5.
They shall not impair the results of the final test of F.8.1.2.6.

Annex G
(normative)

**Additional requirements for control circuit devices
with integrally connected cables**

G.1 General

This annex gives additional requirements applying to control circuit devices with integrally connected cables for electrical connection to other equipment and/or to the power source.

The cable integrally connected to such control circuit devices is not considered replaceable by the user. This annex states the constructional and performance requirements for the cable, the cable anchorage and the cable entrance seal.

G.2 Definitions

For the purpose of this annex, the following definitions apply:

G.2.1

cable connected control circuit device

control circuit devices having integrally connected leads for electrical connection to other equipment and/or to the power source

G.2.2

cable entrance sealing means

sealing means between the cable and device enclosure providing the required protection from cable abrasion and which may provide required sealing of enclosure and cable anchorage

G.2.3

cable anchorage

means to relieve mechanical stress from the cable termination so as to prevent damage to the electrical connection between the device and the cable

G.7 Constructional and performance requirements

G.7.1 Constructional requirements

G.7.1.1 Cable material

The control circuit device shall be provided with flexible cable of appropriate voltage, current and temperature rating and environmental condition.

NOTE The length of cable provided may be specified in the relevant product standard.

G.7.1.2 Cable anchorage

The cable anchorage shall be such that a force being applied to the cable is not transmitted to electrical connections integral to the device.

Movement of the cable into or out of the control circuit device shall not cause damage to the cable connection or internal parts of the device.

G.7.1.3 Cable entrance sealing means

A sealing means shall be provided at the cable entrance to the control circuit device suitable for the degree of protection specified for the device (see Annex C of IEC 60947-1).

NOTE The sealing means may be inherent in the device encapsulation.

G.7.2 Performance requirements

The cable and the cable entrance sealing means shall be capable of withstanding the tests given in G.8.

G.8 Tests

The purpose of these tests is to ensure integrity of the cable anchorage during handling and installation. Once installed, the control circuit device and cable should be fixed relative to each other.

G.8.1 Type tests

The following sequence of four tests shall be performed on a representative sample in the specified order.

G.8.1.1 Pull test

The cable shall be subjected to a steady pull along the axis of the cable entry, applied to the insulating jacket of the cable for a duration of 1 min.

The pull force shall be 160 N for a cable diameter greater than or equal to 8 mm. The pull force for cable diameters of less than 8 mm shall be of the value (in N) of 20 times the external cable diameter (in mm).

G.8.1.2 Torque test

The cable shall be subjected to a torque of 0,1 N·m or limited to the value giving an angle of torque of 360°. The torque shall be applied clockwise for 1 min and then counter-clockwise for 1 min, to the cable at a distance of 100 mm from the control circuit device entrance.

G.8.1.3 Push test

The push force shall be applied along the axis of the cable as close as possible to the cable entrance.

The force is increased slowly to 20 N. The force shall be applied for 1 min for each time and with 1 min pause between applications.

After the tests, no visible damage of the cable entrance sealing means and no displacement of the cable shall be observed.

G.8.1.4 Bend test

The cable shall be loaded and bent in the following manner:

- a) suspend a 3 kg mass by attaching it to the cable, 1 m from the cable entrance and with the axis of the cable entrance vertical;
- b) tilt the control circuit device 90° to cause a 90° bend in the cable, maintaining that position for 1 min;
- c) tilt the control circuit device 90° in the opposite direction relative to vertical so as to cause an opposite 90° bend in the cable, maintaining the position for a duration of 1 min.

G.8.2 Results to be obtained

There shall be no damage to the cable, cable sealing means, cable entrance or the electrical connecting means of the control circuit device. This will be verified by visual examination and verification of compliance with the stated IP designation.

Annex H (normative)

Additional requirements for semiconductor switching elements for control circuit devices

H.1 General

H.1.1 Scope

This annex applies to control circuit devices with semiconductor switching elements for controlling, signalling, interlocking, etc. switchgear and controlgear. These devices shall also comply with the relevant requirements of this standard.

H.1.2 Object

The object of this annex is to state additional requirements for semiconductor switching elements which are not contained in this standard.

H.2 Definitions

In addition to this standard, the following definitions apply.

H.2.1

voltage drop

U_d

the voltage measured across the semiconductor switching element when carrying the operational current under specified conditions

H.2.2

minimum operational current

I_m

the current that is necessary to maintain ON-state conduction of the semiconductor switching element

H.2.3

OFF-state current

I_r

the current which flows through the load circuit when the switching element is in the OFF-state

H.3 Classification

H.3.1 Semiconductor switching elements

- 1) Utilization categories (see 4.4 and H.4.2).
- 2) Electrical ratings based on utilization categories (see Annex A).

H.4 Characteristics

H.4.1 Rated voltage

H.4.1.1 Rated operational voltage (U_e)

Subclause 4.3.1.1 applies.

H.4.1.2 Operational voltage

The operational voltage may be stated as a single value or as a range. When it is stated as a range it shall include all the tolerances of U_e and shall be designated U_B . The relationship between U_e and U_B is shown in Figure H.1.

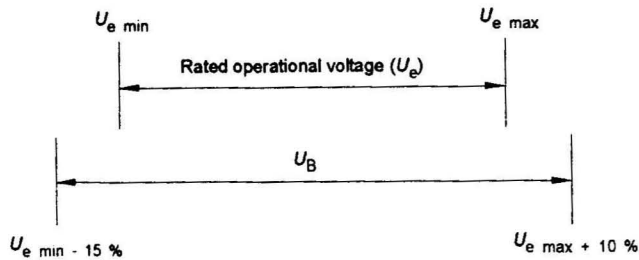


Figure H.1 – Relationship between U_e and U_B

H.4.2 Utilization categories

The utilization categories given in Table 1 are considered standard. Any other types of application shall be based on an agreement between manufacturer and user, but information given in the manufacturer's catalogue or tender may constitute such an agreement.

H.5 Product information

Nature of information

The following information shall be given by the manufacturer: 5.1 applies with the following additions:

Basic rated values and utilization

- a) Voltage drop (see H.7.1.1)
- b) Minimum operational current (see H.7.1.2)
- c) OFF-state current (see H.7.1.3)
- d) Making and breaking capacities (see H.7.2.1)
- e) Conditional short-circuit current (see H.7.3)
- f) Electromagnetic compatibility, EMC (see H.7.4)

H.7 Constructional and performance requirements

H.7.1 Performance requirements

Subclause 7.2 applies with the following additions:

H.7.1.1 Voltage drop (U_d)

The voltage drop, measured across the switching element in the conductive mode, shall be stated by the manufacturer and verified according to H.8.2.

H.7.1.2 Minimum operational current (I_m)

This shall be stated by the manufacturer and verified according to H.8.3.

NOTE In Tables A.2 and A.3, the minimum operational currents are specified for the ratings shown.

H.7.1.3 OFF-state current (I_r)

The maximum current (I_r) which flows through the load in the OFF-state shall be in accordance with the values given in Tables A.2 and A.3, unless otherwise specified in the relevant product standard. The OFF-state current shall be verified according to H.8.4.

H.7.2 Ability to make under abnormal and normal conditions

H.7.2.1 Making and breaking capacities

See 4.3.5.

H.7.3 Conditional short-circuit current

The switching element shall withstand the stresses resulting from short-circuit currents under the conditions specified in H.8.6.

H.7.4 Electromagnetic compatibility (EMC)

Subclause 7.3 of IEC 60947-1 applies.

H.8 Tests

H.8.1 Type tests

Subclause 8.1.2 applies with the following additions:

- a) Voltage drop (see H.8.2)
- b) OFF-state current (see H.8.4)
- c) Making and breaking capacities (see H.8.5)
- d) Performance under short-circuit current conditions (H.8.6)
- e) Verification of electromagnetic compatibility (see H.8.7)
- f) Impulse voltage withstand test (see 8.3.3.4)

H.8.2 Voltage drop (U_d)

The voltage drop is measured across the active output of the switching element in the ON state and carrying the current range of I_m and I_e at an ambient temperature of $23\text{ °C} \pm 5\text{ °C}$ and at the rated frequency. The measurement is performed with the circuit in Figure H.2, with the switch S closed. The loads shall be resistive and R_2 is adjusted to obtain the test current with the supply voltage U_e .

The measured voltage drop shall not exceed the value specified in H.7.4.1.

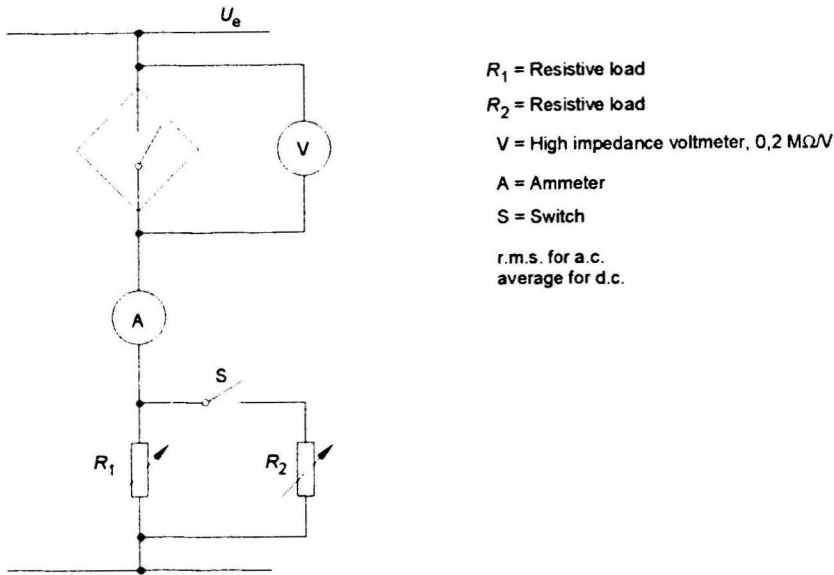


Figure H.2 – Example of test circuit for the verification of voltage drop, minimum operational current and OFF-state current (see H.8.2, H.8.3 and H.8.4)

H.8.3 Minimum operational current (I_m)

The test is performed with the switching element connected to a test circuit shown in Figure H.2. With supply voltage (U_e), the switch open and the switching element in ON-state conduction, the resistive load R_1 is adjusted to obtain the current I_m . The measured value shall be according to H.7.1.2.

H.8.4 OFF-state current (I_r)

With the circuit in Figure H.2, and the S switch closed, the load R_2 is adjusted to obtain the rated operational current (I_e) when the highest supply voltage (U_e) is connected to the circuit. The switching element is then turned off and the OFF-state current is measured. The current shall be according to H.7.1.3.

H.8.5 Making and breaking capacities

Subclause 8.3.3.5 applies.

H.8.6 Performance under short-circuit current conditions

H.8.6.1 Test circuit and test procedure

A new switching element shall be mounted as in service, in free air, and connected to the test circuit using a 2 m total length cable suitable for the operational current of the switching element (see Figure H.3).

The short-circuit protective device (SCPD) shall be of the type and rating stated by the manufacturer. This SCPD shall be omitted if the switching element is integrally protected against short circuit.

The loads, R and L are so selected that the current flowing through the switching element is equal to its rated operational current at the rated operational voltage (U_e) and at the power factor or $T_{0,95}$ time constant stated in Table 5 or in Table H.3. The supply S shall be adjusted to a prospective short-circuit current of 1 000 A, unless otherwise specified in the product standard, at the rated operational voltage (U_e). The supply circuit shall have air-cored reactors connected in series with resistors to provide a power factor of 0,5 to 0,7. No damping load shall be added parallel with the reactors. The open circuit voltage shall be 1,1 times the maximum rated operational voltage of the switching element.

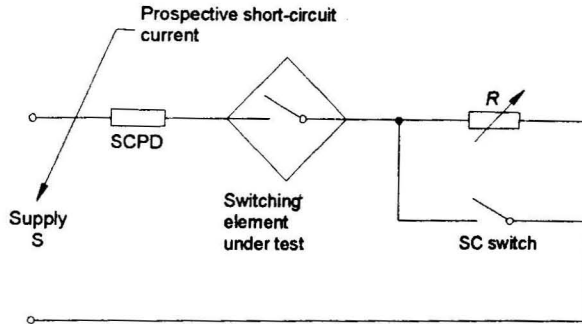


Figure H.3 – Short-circuit testing (see H.8.6.1)

The test shall be performed three times by randomly closing the "SC" switch. The test current is maintained until the SCPD operates or in the case of self-protecting elements, for 30 min. After each test the SCPD shall be replaced or reset. The interval between each of the three tests shall be not less than 3 min. The actual time between tests shall be stated in the test report.

H.8.6.2 Condition of the switching element after the test

Subclause 8.3.4.4 applies.

H.8.7 Verification of electromagnetic compatibility

H.8.7.1 General

Emission and immunity tests are type tests and shall be carried out under the following common conditions.

The switching element is mounted in free air connected to a load corresponding to the rated operational current (I_e) and is supplied with its rated operational voltage (U_e), or the maximum voltage of its voltage range.

The connecting leads shall be 2 m in length.

The tests shall be performed

- a) with the switching element in the ON-state,
- b) with the switching element in the OFF-state.

H.8.7.2 Immunity

H.8.7.2.1 General

Performance criteria are based on the acceptance criteria in Table 24 of IEC 60947-1.

Performance criterion A: During the tests, the output state of the switching element shall not change.

Performance criterion B: During the tests, the output state of the switching element shall not change for more than 1 ms for d.c. devices or one half-wave of supply frequency for a.c. devices.

Performance criterion C: Temporary degradation or loss of performance which is self recoverable or requires system reset.

Table H.1 – Immunity tests

Type of test	Test level required	Acceptance criteria
Electrostatic discharges IEC 61000-4-2	8 kV / air discharge or 4 kV / contact discharge	B
Radiated radio-frequency electromagnetic fields (80 MHz to 1 GHz) IEC 61000-4-3	10 V/m	A
Electrical fast transients/bursts IEC 61000-4-4	2 kV on power ports ¹⁾ 1 kV on signal ports ²⁾	B
Surges (1,2/50 μ s – 8/20 μ s) IEC 61000-4-5 ³⁾	2 kV (line to earth) 1 kV (line to line)	B
Conducted disturbances induced by radio-frequency fields (150 kHz to 80 MHz) IEC 61000-4-6	10 V	A
Power-frequency magnetic fields IEC 61000-4-8	30 A/m	A
Voltage dips and interruptions IEC 61000-4-11	Reduction to 30 % U_T for 0,5 cycle Reduction to 60 % U_T for 5 and 50 cycles	B
Harmonics in the supply IEC 61000-4-13	No requirements ⁴⁾	–
¹⁾ Power port: the point at which a conductor or cable carrying the primary electrical power needed for the operation of the switching element or associated equipment is connected. ²⁾ Signal port: the point at which a conductor or cable carrying information for transferring data or signals is connected to the switching element. ³⁾ Not applicable for ports with a rated voltage of 24 V d.c. or less. ⁴⁾ Test levels are under study for the future.		

H.8.7.2.2 Electrostatic discharges

The test shall be performed according to IEC 61000-4-2 and Table H.1.

H.8.7.2.3 Radiated radio-frequency electromagnetic fields

The test shall be performed according to IEC 61000-4-3 and Table H.1.

If the worst case direction is known, then the test need only be performed in that direction. Otherwise, the electromagnetic field shall be faced to the device under test in three mutually perpendicular directions.

H.8.7.2.4 Electrical fast transients/bursts

The test shall be performed according to IEC 61000-4-4 and Table H.1, with the connecting leads of the device placed in the capacitive coupling clamp.

NOTE The capacitive coupling is the preferred test method because it simulates the disturbances present during normal application as a result of parallel wires.

H.8.7.2.5 Surges

The test shall be performed according to IEC 61000-4-5 and Table H.1, with the following additional requirements in order to simplify the test procedure without impairing the validity of the verification of the EMC requirements:

- the switching element is powered during the test.
- the impulse test shall be applied:
 - a) between terminals intended to be connected to the power supply;
 - b) between each output terminal and each terminal intended to be connected to the power supply.
- Three positive and three negative impulses shall be applied between each two points at intervals of not less than 5 s.

H.8.7.2.6 Conducted disturbances induced by radio-frequency fields

The test shall be performed according to IEC 61000-4-6 and Table H.1.

H.8.7.2.7 Power-frequency magnetic fields

The test shall be performed according to IEC 61000-4-8 and Table H.1.

Applicable only to equipment containing devices susceptible to power-frequency magnetic fields.

H.8.7.2.8 Voltage dips and interruptions

The test shall be performed according to IEC 61000-4-11 and Table H.1.

Applicable only to a.c. switching elements.

H.8.7.3 Emission

The test shall be performed under worst case conditions according to CISPR 11 Group 1, Class A, and 7.3.3.2 of IEC 60947-1.

These limits are given for switching elements exclusively intended for use in industrial environment A. When they can be used in domestic environment B, the following notice shall be included in the instructions for use:

NOTICE

This is a Class A product. In a domestic environment this product may cause radio interference in which case the user may be required to take adequate measures.

Annex J (normative)

Special requirements for indicator lights and indicating towers

J.1 General

J.1.1 Scope

This annex applies to indicator lights and indicating towers, which shall also comply with the relevant requirements of this standard.

J.1.2 Object

This annex gives additional requirements applicable to indicator lights, together with definitions and terms useful for stating the required characteristics of design and performance.

J.2 Definitions

The following additional definitions are applicable:

J.2.1

indicator light

light signal giving information either by lighting or extinguishing

J.2.2

lens of an indicator light

visible part, removable or not, constituting the surface intentionally made transparent or translucent

J.2.3

bezel

holder of a lens

J.2.4

indicator light with a built-in voltage-reducing device

indicator light, the body of which contains a device (transformer, resistor, etc.) intended to supply, at the terminals of a lamp, a voltage different from the rated operational voltage of the light

J.2.5

indicating tower

assembly including one or more signalling units giving information by visible or audible signals

NOTE Other elements, e.g. network interface elements may be added.

J.3 Classification

Indicator lights may be classified by:

- the rated electrical power;
- the colour;
- the fixing hole diameter;
- the means of connection;
- the nature of the current applied and its frequency, if any (for example lights with built-in transformers);
- the type of lamp socket.

J.4 Characteristics

J.4.1 Rated operational voltage of an indicator light

A value of voltage, assigned by the manufacturer which determines the application of the indicator light.

J.4.2 Rated thermal power of an indicator light

The maximum lamp power which an indicator light is designed to tolerate under conditions specified for the temperature-rise test.

NOTE As the power of the light has an effect on the temperature rise, it may be necessary to limit the power according to the mounting conditions; the manufacturer of the indicator light may assign two values of rated power (see J.8.3.3.3):

- the rated power of the light for mounting on a steel plate;
- the rated power of the light for mounting in an insulating enclosure.

J.4.3 Rated values of the lamp

Rated value of the lamp(s) indicated by the manufacturer and with which the indicator light operates without attaining temperatures likely to damage its parts.

NOTE 1 Rated power and voltage may be indicated by a type designation.

NOTE 2 It is assumed that a lamp does not dissipate a power higher than its rated power at its rated voltage.

J.5 Product information

The applicable requirements are:

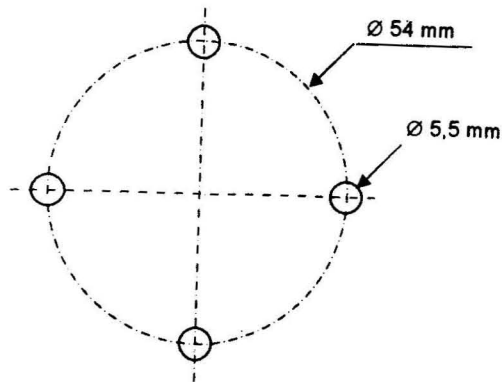
Items a) and b) of 5.1;

- c) the following markings shall appear on the indicator light:
 - 1) rated voltage of the indicator light;
 - 2) rated voltage of the lamp (if different from the rated voltage of the indicator light).
 - 3) rated power of the lamp or its type designation, or rated current for a LED.

J.6 Normal service, mounting and transport conditions

There are no supplementary requirements.

The following mounting dimensions for the indicating tower socket are recommended:



J.7 Constructional and performance requirements

Clause 7 applies with the following additions:

J.7.1.12 Indicator lights with built-in transformers

The transformer shall have separate windings.

It is assumed that this condition is fulfilled if the indicator light passes the test described in 8.3.3.4.1.

J.7.1.13 Colour of the lens

It is recommended that the colour of the lens be chosen among those mentioned in IEC 60073 and also in Publication No. 2 of the International Commission of Illumination (CIE).

The colour shall remain essentially unchanged in spite of the adverse influence of the environment, including the effect of ultra-violet light.

Colours used for identification shall be bright and easily distinguishable.

NOTE For indicating towers on machines, the fifth edition of IEC 60204-1¹⁾ (under preparation) requires the following sequence of colours from top down: red, yellow, blue, green and white.

J.7.2.1.6 Limits of operation

The limiting value of the supply voltage at the terminals of the indicator light shall be 1,1 times the rated operational voltage. This requirement is verified only for indicator lights with built-in transformer according to J.8.3.4.

J.7.2.5.1 Short-circuit withstandability of built-in transformer

The transformer shall be able to withstand permanently the short circuit of its secondary winding. It is assumed that this condition is fulfilled if the indicator light passes the test described in J.8.3.3.3.

¹⁾ IEC 60204-1, *Safety of machinery – Electrical equipment of machines – Part 1: General requirements*

J.8 Tests

J.8.3 Tests for indicator lights and indicating towers

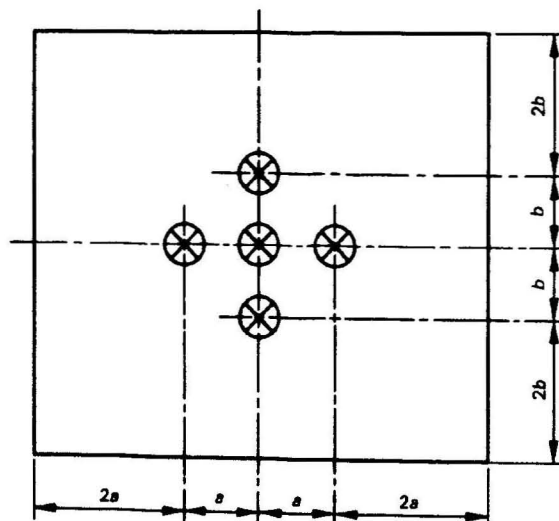
The tests are type tests. No additional test (routine test or special test) is prescribed in this annex.

Each of the tests in J.8.3.3.3, J.8.3.3.4, J.8.3.4 and J.8.4 shall be made on new apparatus mounted in accordance with the test instructions.

J.8.3.3.3 Temperature-rise tests

- a) If the indicator light has the same rated thermal power (see J.4.2) regardless of mounting conditions, a single test is made in an insulated enclosure.
- b) If the rated thermal power (see J.4.2) is dependent on the mounting conditions, two tests are made:
 - on a steel plate, and
 - in an insulated enclosure.
- c) Mounting on a steel plate

Five indicator lights fitted with green lenses are fixed in accordance with the following diagram on a steel plate 2 mm thick, painted mat black:



Dimensions a and b are:

- 1) for indicator lights forming an integral part of a push-button range: in accordance with 6.3.1.3;
- 2) for other indicator lights: as stated by the manufacturer, but the values used shall be recorded in the test report.

The indicator lights are fitted with lamps as stated by the manufacturer and, if any, with built-in devices such as transformers, resistances, etc. The conductor sizes shall be as specified in 8.3.3.3.

The plate is located vertically on a table and the indicator lights are supplied at their rated voltage. The duration of the test shall be such that a steady-state temperature is reached.

d) Mounting in an insulating enclosure

The test described in item c) is carried out again with the indicator lights mounted into an enclosure of insulating material, such as bakelite-coated paper 2 mm thick, the front face of which has the same dimensions as the steel plate and the depth of which is 110 mm. The indicator lights are fitted with lamps and mounted as stated by the manufacturer for this type of use; they are supplied at their rated operational voltage.

The duration of the test shall be such that a steady-state temperature is reached.

e) Results to be obtained

At the end of each of the tests described in items c) and d) the temperatures are measured:

- on the body of the indicator light;
- on the terminals;
- on the accessible part of the lens.

f) For indicating towers, an arrangement of five visual signalling units shall be mounted in a vertical position. The upper three signalling units, or the maximum number stated by the manufacturer if greater than three, shall be equipped with the maximum power lamp of signalling units as stated by the manufacturer and powered at the rated voltage. After the steady state temperature is reached, the temperature shall be measured on top of the tower and on the lens of the centre element of the complete tower.

None of the corresponding temperature-rises shall exceed the limits referred to in 7.2.2 of IEC 60947-1.

J.8.3.3.4 Dielectric tests

8.3.3.4 applies.

J.8.3.3.4.3 Indicator lights with built-in transformers

Two additional dielectric tests shall be made, the duration of each being 1 min:

- between the primary and secondary windings of the transformer with the test voltage value specified in 8.3.3.4;
- between the secondary windings of the transformer and the frame of the indicator light with a test voltage value of 1 000 V.

J.8.3.4 Short-circuit test (on built-in transformers, if any)

The test shall be made under the following conditions:

- primary voltage: $1,1 \times U_n$;
- ambient air temperature: $20\text{ °C} \pm 5\text{ °C}$;
- duration of the test: 1 h.

The transformer shall be short-circuited by a conductor of negligible impedance.

After the test and after cooling to ambient temperature, the transformer shall withstand the dielectric test defined in J.8.3.3.4.3.

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J.8.4 Shock and vibration

J.8.4.1 Direct mounting

J.8.4.1.1 General

An indicating tower with five signalling units shall be mounted as stated by the manufacturer without extension poles and the upper three units powered at the rated voltage.

The tests shall be performed as follows.

J.8.4.1.2 Shock

In accordance with IEC 60068-2-27 with the following conditions.

Six shocks applied in each direction along three mutually perpendicular axes (a total of 36 shocks):

- pulse shape: half-sine;
- peak acceleration: $15 g_n$;
- duration of the pulse: 11 ms.

J.8.4.1.3 Vibration

In accordance with IEC 60068-2-6 with the following conditions, along three mutually perpendicular axes:

- frequency range: 10 Hz to 55 Hz;
- amplitude: 0,5 mm;
- sweep cycle duration: 5 min;
- duration at resonant frequency or at 55 Hz: 30 min in each of the three axes (90 min in total).

J.8.4.2 Indirect support mounting

If the product literature includes other allowable mounting conditions (e.g. pole mounting), the manufacturer shall state the severity level for shock and vibration tests at which the requirements of J.8.4.3 are met.

J.8.4.3 Results to be obtained

After the tests, no visible damage shall be observed and the signalling shall not be impaired.

J.8.5 Degree of protection for indicating towers

If the manufacturer declares a degree of protection, the test shall be conducted according to Annex C of IEC 60947-1 with all removable parts equipped as in normal service.

Annex K (normative)

Special requirements for control switches with direct opening action

K.1 General

K.1.1 Scope

This annex is applicable to control switches with direct opening action.

All control switches with direct opening action shall also comply with the relevant requirements of the standard and, where applicable, to those given in Annexes F, G, H and/or J.

K.1.2 Object

This annex gives additional requirements applicable to control switches with direct opening action, together with definitions and terms useful for stating the required characteristics of design and performance.

K.2 Definitions

The following additional definitions apply:

K.2.1

control switch with direct opening action

control switch having one or more break-contact elements coupled to the switch actuator via non-resilient members so that full contact opening of the break-contact element(s) is obtained when the actuator is moved through the direct opening travel by applying the force stated by the manufacturer

K.2.2

direct opening action (of a contact element)

achievement of contact separation as the direct result of a specified movement of the switch actuator through non-resilient members (for example not dependent upon springs)

K.2.3

direct opening travel

travel from the beginning of actuation of the actuator and the position when the direct opening action of the opening contacts is completed

K.2.4

direct opening force (or moment)

actuation force, or actuating moment for a rotary control switch, applied to the actuator for the direct opening action

K.3 Classification

There are two types of control switches with direct opening action:

Type 1: Having one contact element only, this contact element is a direct opening break-contact element.

Type 2: Having one or more break-contact elements, and possibly, one or more make-contact elements and/or one or more change-over contact elements. All break-contact elements including the break part of change-over contact elements shall be direct opening break-contact elements.

K.4 Characteristics

The following additional characteristics apply:

K.4.3.1.2 Rated insulation voltage

The minimum value of the rated insulation voltage shall be 250 V.

K.4.3.2.1 Conventional free air thermal current

The minimum value of the conventional free air thermal current is 2,5 A.

K.4.4 Utilization categories for switching elements

The utilization categories shall be AC-15 or DC-13.

NOTE Additional utilization categories AC-14 and DC-14 are permitted.

K.5 Product information

Clause 5 is applicable with the following additions:

K.5.2 Marking

K.5.2.7 Direct opening action

Every contact element with direct opening action shall be indelibly and legibly marked on the outside by the symbol:



K.5.2.8 Electrical separation for change-over contact elements

Change-over contact elements with four terminals shall be indelibly and legibly marked with the relevant form Za or Zb as stated in Figure 4.

K.5.4 Additional information

K.5.4.1 Actuator travel and operating force

The manufacturer shall state the following:

- a) the minimum direct opening travel;
- b) the minimum force required to achieve direct opening action of all break contacts;
- c) the maximum travel including travel beyond the minimum travel position (i.e. including overtravel);
- d) for limit switches only the maximum speed of actuation;
- e) for limit switches only the maximum frequency of actuation.

These statements shall appear in the marking or on the circuit diagram or other documents published by the manufacturers.

NOTE 1 See also K.7.1.5.3.

NOTE 2 Type 2 control switches may open with less travel than the direct opening travel stated by the manufacturer.

K.5.4.2 Short-circuit protection

The type of short-circuit protective device shall be stated either as marking on the switch or in the installation instructions.

K.6 Normal service, mounting and transport conditions

Clause 6 applies, with the following additions:

K.6.1.1 Ambient air temperature

Subclause 6.1.1 of IEC 60947-1 applies, except for position switches with direct opening action, for which the upper and lower limits of temperature are respectively +70 °C and -25 °C, and the average temperature, measured over a period of 24 h, does not exceed +35 °C.

NOTE The choice of the connecting conductors may, if necessary, be subject to agreement between manufacturer and user (see note 1 of Table 2 of 60947-1).

K.7 Constructional and performance requirements

Clause 7 applies with the following additions:

K.7.1.4.3.1 Robustness of the actuating system

In order to have sufficient robustness, the actuating system shall pass the test described in K.8.3.7.

K.7.1.4.3.2 Directness of opening action

A control switch with direct opening action shall pass the tests described in K.8.3.4, K.8.3.5 (in the case of a position switch with a direct opening action), and K.8.3.7 without any deformation that would reduce the impulse voltage withstand across the contact gap.

K.7.1.4.5 Automatic opening of cable operated control switches

Cable operated control switches with direct opening action shall return automatically to the open position in case of failure of the cable or its anchorage.

K.7.1.4.6 Conditions for direct opening action (see 2.4.10 of IEC 60947-1)

For parts of the travel that separates the contacts, there shall be a positive drive with no resilient member (for example springs) between the moving contacts and the point of the actuator to which the actuating force is applied.

K.7.1.4.6.1 Contact element types

Control switches with direct opening action may be provided with snap action or dependent action contact elements.

The break-contact elements shall be electrically separated from each other and from the operating make-contact elements.

When the control switch has form C or form Za change-over contact elements (see Figures 4 c) and 4 d)), only one contact element (make or break) shall be used. In the case of form Zb change-over contact elements, both contacts may be used.

K.7.1.5.3 Actuator travel indication

In order to facilitate the setting up of the switch actuator in relation to the external operating means, for example a cam, the switch may include means for indicating the minimum travel of the actuator required to ensure direct opening action, for example by the provision of a mark on the actuator plunger (see note 1, item a) of K.5.4.1).

K.8 Tests

In addition to clause 8, and Annex C, the following applies:

K.8.3.1 Test sequences

Subclause 8.3.1 applies with the following additions:

- Test sequence VII (sample No. 7) – Mechanical operation of position switches with direct opening action.
 - Test No. 1 – Mechanical operation at limits of temperature (see K.8.3.5).
 - Test No. 2 – Verification of direct opening action (see K.8.3.6).
- Test sequence VIII (sample No. 8)
- Verification of robustness of the actuating system (see K.8.3.7).

K.8.3.4 Performance under conditional short-circuit current

Subclause 8.3.4 applies with the following additions:

K.8.3.4.2.1 Verification of conditional short-circuit current

The test shall be made as stated in 8.3.4.2, except that the current is made by a positive opening contact element and not by the additional switching device and the test is made on each of the three devices by making the current three times by the same contact element in a single phase circuit.

For type 2 control switches, the contact element shall be chosen at random.

K.8.3.4.4.1 Operation ability after the test

After each test, the opening contact element shall open by the application of the force stated by the manufacturer through the positive opening travel (see items a) and b) of K.5.4.1).

The open position of the contact element shall be verified by the application of an impulse test voltage of 2 500 V across the contact gap.

K.8.3.5 Verification of mechanical operation of position switches at limits of temperature

This test applies only to position switches with direct opening action. The position switch shall be conditioned at +70 °C for 8 h.

At the end of the conditioning period and at the same temperature, the contacts shall be loaded with the maximum rated operational current for 10 min. The contacts shall then be operated 10 times by the application of the force stated by the manufacturer according to item b) of K.5.4.1.

The test shall be repeated after conditioning at -25 °C but without application of the current.

After completion of this test, the open position of the contacts shall be verified according to K.8.3.6.

K.8.3.6 Verification of direct opening action

When the position switch is in the position corresponding to the direct opening travel stated in item a) of K.5.4.1, the contact gap shall withstand an impulse voltage of 2 500 V.

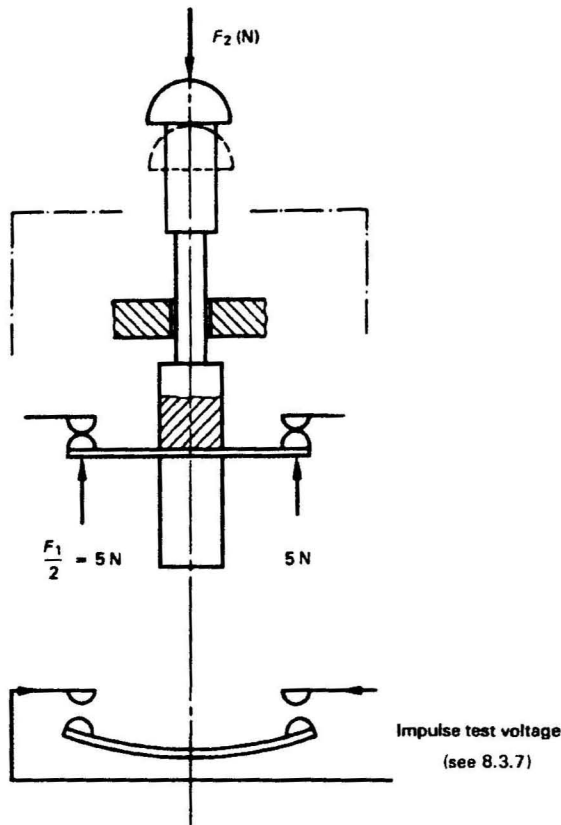
For position switches suitable for isolation, the value of the impulse withstand voltage shall be in accordance with Table 14 of IEC 60947-1 corresponding to the rated impulse withstand voltage U_{imp} declared by the manufacturer.

K.8.3.7 Verification of robustness of the actuating system

The closed break contact(s) shall be loaded with a force F_1 of 10 N (see Figure K.1). A force (moment) F_2 , higher than F_1 , stated by the manufacturer, shall be applied to the actuator through the direct opening travel.

After this test, the actuating system and/or contacts shall remain functional and shall withstand an impulse test voltage in accordance with K.8.3.6.

For position switches suitable for isolation, the value of the impulse withstand voltage shall be in accordance with Table 14 of IEC 60947-1 corresponding to the rated impulse withstand voltage U_{imp} declared by the manufacturer.



NOTE - F_1 = Required opening force = 10 N.
 F_2 = Force (moment) stated by the manufacturer.

Figure K.1 – Verification of robustness of the actuating system

Annex L (normative)

Special requirements for mechanically linked contact elements

L.1 General

L.1.1 Scope

This annex applies to mechanically linked auxiliary contact elements included in control circuit devices where actuating force is provided internally, such as contactor-relays.

Linkage between the auxiliary and main contacts is not covered by this annex.

NOTE 1 A typical application of mechanically linked contact elements is e.g. self-monitoring in machine control circuits.

NOTE 2 Mechanically linked contact elements have previously been referred to as forced contacts, positively activated contacts, or linked contacts, or, in French: "contacts forcés" or in German: "Zwangsgeführte Kontakte".

NOTE 3 Control circuit devices actuated externally (e.g. push-button or limit-switches) do not have an actuating force limited to a maximum value (see L.8.4 a) 2)), so they cannot have mechanically linked contact elements. For such devices, safety applications generally use contacts with "direct opening action" (see Annex K).

L.1.2 Object

This annex provides additional specifications (definition, requirements and tests) which shall be used for stating the required design characteristics, marking and performance of mechanically linked contact elements.

L.2 Definition

The following additional definition applies:

L.2.1

mechanically linked contact elements

combination of n Make contact element(s) and m Break contact element(s) designed in such a way that they cannot be in closed position simultaneously under conditions defined in L.8.4

NOTE 1 One control circuit device may have more than one group of mechanically linked contact elements.

NOTE 2 See also L.7.1.9.

L.3 Classification

Clause 3 applies.

L.4 Characteristics

All mechanically linked contact elements shall also comply with the relevant requirements given in this standard.

L.5 Product information

Clause 5 applies with the following addition:

L.5.2.7 Mechanically linked contact elements identification and marking

Mechanically linked contact elements shall be clearly identified:

- on the control circuit device itself;
- or in the manufacturer's documentation;
- or both.

The mechanical linkage shall be identified in circuit diagrams by a double parallel line connecting a filled circle on each of the mechanically linked contact symbols. An example is given in Figure L.1.

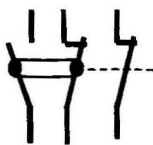


Figure L.1 – Example of representation of NO and NC contacts which are mechanically linked and NC non-linked contact

If devices containing some or all mechanically linked contacts are marked, the symbol shown in Figure L.2 shall be used.



Figure L.2 – Symbol for device containing mechanically linked contacts

L.6 Normal service, mounting and transport conditions

There are no supplementary requirements.

L.7 Constructional and performance requirements

Clause 7 applies with the following addition:

L.7.1.9 Requirements for mechanically linked contact elements

While any of the n Make contact element(s) is closed, none of the m Break contact element(s) shall be closed.

While any of the m Break contact element(s) is closed, none of the n Make contact element(s) shall be closed.

L.8 Tests

Clause 8 applies with the following addition:

L.8.4 Special test for mechanically linked contact elements

This special test shall be carried out on a sample of $(m + n)$ products where m is the number of break contact element(s) and n is the number of make contact element(s).

A different sample is used for each test.

The tests shall be carried out on products in new and clean condition. The test procedure shall be as follows:

a) Test of NC contact:

- 1) the NC contact element shall be maintained in the closed position e.g. by welding or gluing each point of contact (e.g. for double breaking contact, welding is done at the two contacts points). The thickness of welding or gluing shall be such that the distance between contacts is not modified by more than 0,02 mm;
- 2) an actuating force shall be applied by energising the operating coil at 110 % of its rated voltage;
- 3) while applying the force, an impulse test voltage of 2,5 kV (1,2/50 μ s at sea level; correction should be made according to Table 12 of IEC 60947-1) shall be applied across every NO contact. There shall be no disruptive discharge.

NOTE This test ensures a minimum gap of 0,5 mm in accordance with Table 13 of IEC 60947-1.

b) Test of NO contact:

- 1) an actuating force shall be applied by energising the operating coil at its rated voltage;
- 2) the NO contact element shall be maintained in the closed position e.g. by welding or gluing each point of contact (e.g. for double breaking contact, welding is done at the two contacts points). The thickness of welding or gluing shall be such that the distance between contacts is not modified by more than 0,02 mm;
- 3) an actuating force shall be applied by de-energising the operating coil;
- 4) with the operating coil de-energised, an impulse test voltage of 2,5 kV (1,2/50 μ s at sea level; correction should be made according to Table 12 of IEC 60947-1) shall be applied across every NC contact. There shall be no disruptive discharge.

NOTE This test ensures a minimum gap of 0,5 mm in accordance with Table 13 of IEC 60947-1.

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